

# Radiometry and Appearance Models

Szymon Rusinkiewicz  
Princeton University

SIGGRAPH 2008 Class

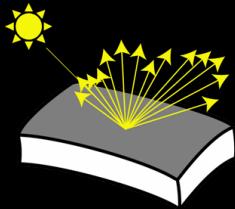
Los Angeles, August 2008

## The Visual World

Rich variety of **materials**: characterized by surface reflectance, scattering

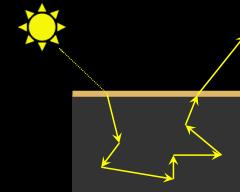


## Understanding Reflectance



**for each** position:  
**for each** direction of incident light:  
**for each** reflected direction:  
*how much* light is reflected?

## Understanding Scattering



**for each** incident position:  
**for each** exitant position:  
*how much* light is scattered?

## Motivation

- Understanding appearance models aids in:
  - Photorealistic image synthesis
  - Image-based view and lighting interpolation
  - 3D reconstruction from images
  - Image interpretation
  - Understanding human material perception

## Overview

- Radiometry and Radiometric Units
- BRDF properties and common BRDFs
- Subsurface scattering
- Taxonomy of reflection and scattering functions

## Radiometric Units

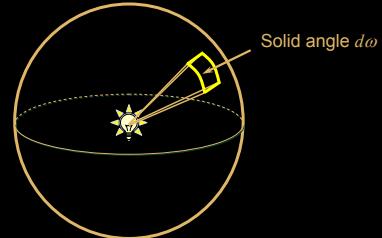


- Light is a form of energy - measured in Joules (J)
- Power: energy per unit time
  - Measured in Joules/sec = Watts (W)
  - Also called Radiant Flux ( $\Phi$ )

## Point Light in a Direction



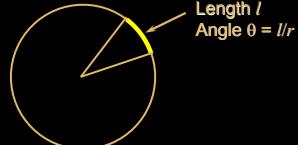
- Total radiant flux in Watts
- How to define angular dependence?
  - Solid angle



## Digression – Solid Angle



- Angle in radians



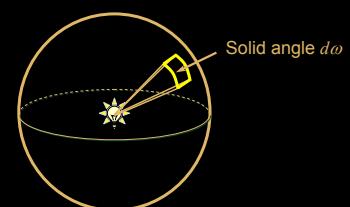
- Solid angle in steradians



## Point Light in a Direction



- Total radiant flux in Watts
- How to define angular dependence?
  - Solid angle



- Radiant flux per unit solid angle
  - Measured in Watts per steradian (W/sr)

## Light Falling on a Surface



- Power per unit area - Irradiance (E)
  - Measured in W/m<sup>2</sup>



- Move surface away from light
  - Inverse square law:  $E \sim 1/r^2$



## Light Emitted from a Surface in a Direction



- Power per unit area per unit solid angle - Radiance (L)
  - Measured in W/m<sup>2</sup>/sr
  - *Projected area* - perpendicular to given direction



$$L = \frac{d\Phi}{dA d\omega}$$

- Cameras (and our eyes) “see” radiance

## Surface Reflectance – BRDF



- Bidirectional Reflectance Distribution Function

$$f_r(\omega_i \rightarrow \omega_o) = \frac{dL_o(\omega_o)}{dE_i(\omega_i)}$$

- 4-dimensional function: also written as

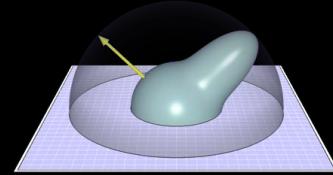
$$f_r(\theta_i, \phi_i, \theta_o, \phi_o) = \frac{dL_o(\omega_o)}{dE_i(\omega_i)}$$

F. E. Nicodemus, J. C. Richmond, J. J. Hsia, and I. W. Ginsberg,  
*Geometrical Considerations and Nomenclature for Reflectance*,  
Boulder CO: National Bureau of Standards, 1977.

## BRDF



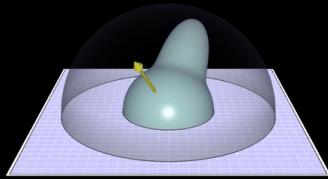
- Radiance/irradiance ratio
  - Directional exitant radiance distribution
  - For each direction of incident irradiance



## BRDF



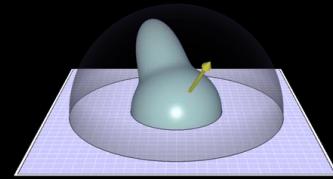
- Radiance/irradiance ratio
  - Directional exitant radiance distribution
  - For each direction of incident irradiance



## BRDF



- Radiance/irradiance ratio
  - Directional exitant radiance distribution
  - For each direction of incident irradiance



## Properties of the BRDF



- Energy conservation:

$$\int_{\Omega} f_r \cos \theta_o d\omega_o \leq 1$$

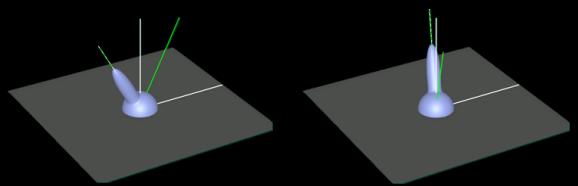
- Helmholtz reciprocity:

$$f_r(\omega_i \rightarrow \omega_o) = f_r(\omega_o \rightarrow \omega_i)$$

## Isotropy



- A BRDF is isotropic if it stays the same when surface is rotated around normal



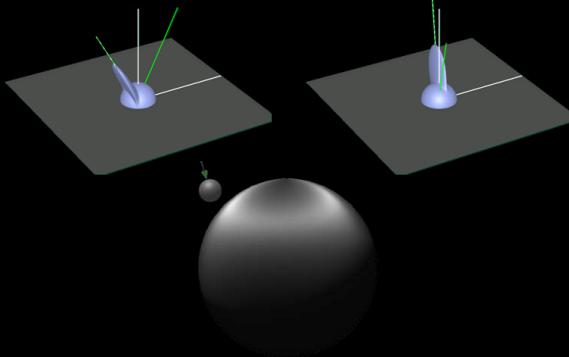
- Isotropic BRDFs are 3-dimensional functions:

$$f_r(\theta_i, \phi_i, \theta_o, \phi_o)$$

## Anisotropy



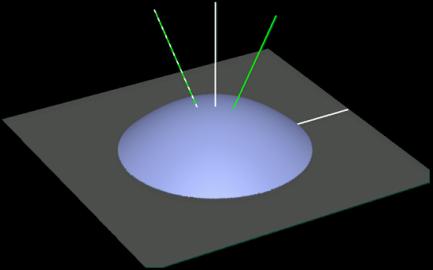
- Anisotropic BRDFs **do** depend on surface rotation



## Other BRDF Features



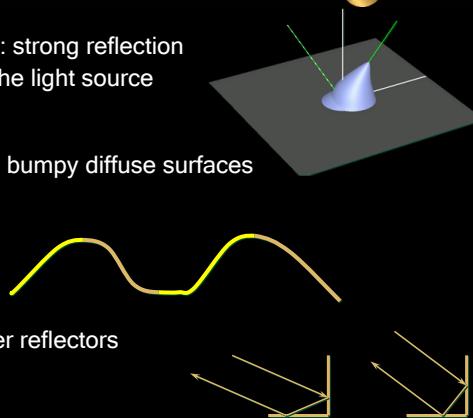
- BRDFs for dusty surfaces scatter light towards grazing angles



## Other BRDF Features



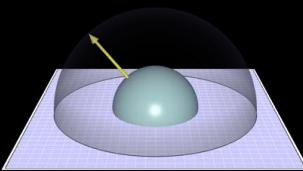
- Retroreflection: strong reflection back towards the light source
- Can arise from bumpy diffuse surfaces
- ... or from corner reflectors



## Lambertian BRDF



- Constant BRDF: ideal diffuse reflectance

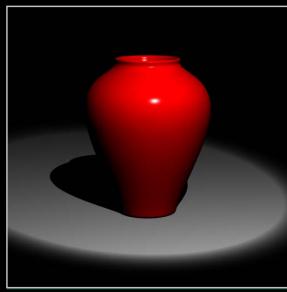
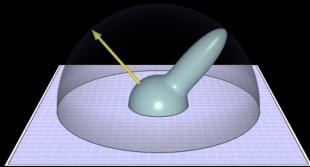


$$f_r = \text{const.} = \frac{\rho}{\pi}$$

## Blinn-Phong BRDF



- Simple BRDF describing specular reflection



$$f_r = \frac{\rho}{\pi} + k_s (n \cdot h)^\alpha$$

## Torrance-Sparrow BRDF



- Physically-based BRDF model
  - Originally used in the physics community

$$f_r = \frac{DGF}{\pi \cos \theta_i \cos \theta_o}$$

- Assume surface consists of tiny “microfacets” with mirror reflection off each



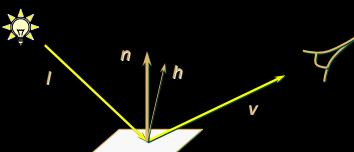
## Torrance-Sparrow BRDF



- $D$  term is distribution of microfacets (i.e., how many are pointing in each direction)
- Beckmann distribution

$$D = \frac{e^{-[(\tan \beta)/m]^2}}{4m^2 \cos^4 \beta}$$

$\beta$  is angle between  $n$  and  $h$   
 $h$  is halfway between  $l$  and  $v$   
 $m$  is "roughness" parameter

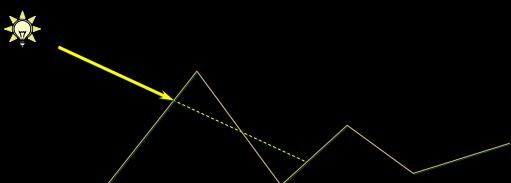


## Torrance-Sparrow BRDF



- $G$  term accounts for self-shadowing

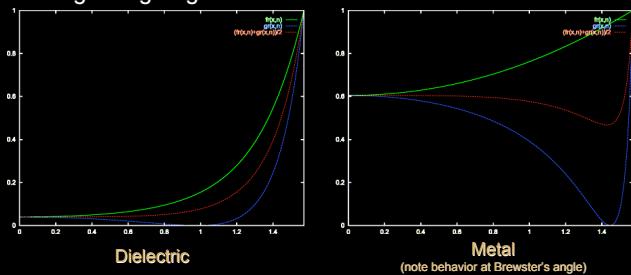
$$G = \min \left\{ 1, \frac{2(n \cdot h)(n \cdot v)}{(v \cdot h)}, \frac{2(n \cdot h)(n \cdot l)}{(v \cdot h)} \right\}$$



## Torrance-Sparrow BRDF



- $F$  is Fresnel term - reflection from an ideal smooth surface (solution of Maxwell's equations)
- Consequence: most surfaces reflect (much) more strongly near grazing angles



## Complex BRDF Models



[COOK & TORRANCE  
1982]

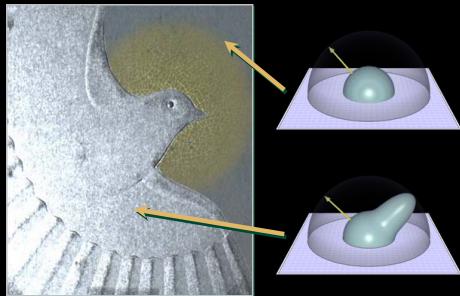


[MATUSIK ET AL.  
2003]

## The SVBRDF: 6D



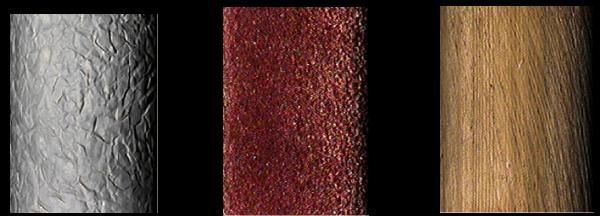
Spatially-  
Varying  
Bi-Directional  
Reflectance  
Distribution  
Function



## Bidirectional Texture Functions



- For non-flat samples, datasets include effects due to occlusion, shadowing
  - Often called *Bidirectional Texture Functions* - BTFs



[DANA ET AL. 1999]

## Translucent Materials



Surface reflection only



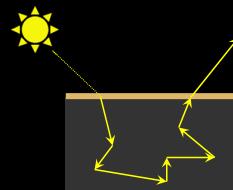
With subsurface scattering

[PEERS ET AL. 2006]

## Subsurface Scattering



- Translucency: light no longer leaves surface at point of incidence
  - Not a BRDF!



## The BSSRDF



- The Bidirectional Scattering-Surface Reflection Distribution Function

$$S(x_i, y_i, \theta_i, \phi_i, x_o, y_o, \theta_o, \phi_o)$$

- Generalization of spatially-varying BRDF

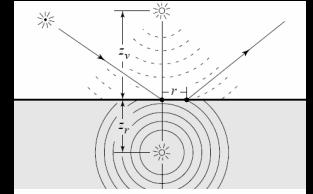
## BSSRDF Simplification



- BSSRDF often dominated by multiple scattering
- Accurately modeled by **diffusion** approximation

$$S = F(\theta_i) R(\|x_i - x_o\|) F'(\theta_o)$$

- Angular behavior described by Fresnel equations
- Spatial behavior equivalent to a dipole



## BSSRDF Dipole Model



Surface reflection only



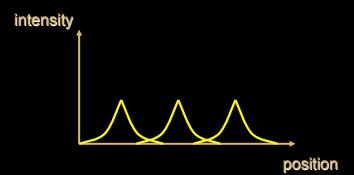
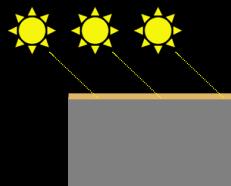
With subsurface scattering

[WANN JENSEN ET AL. 2001]

## BSSRDF: Homogeneous



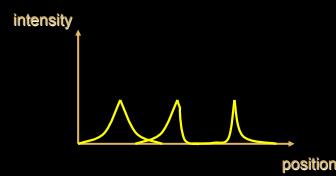
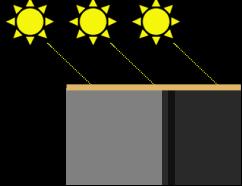
- Homogeneous: uniform material



## BSSRDF: Heterogeneous



- Homogeneous: uniform material
- Heterogeneous: spatially-varying materials



## Heterogeneous Scattering



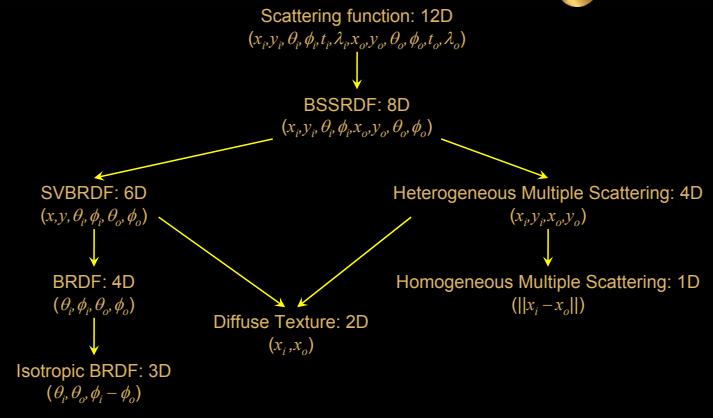
[PEERS ET AL. 2008]

## Generalizing Further



- Many additional effects could be incorporated into appearance functions: add 1 dimension for each
  - Wavelength
  - Fluorescence
  - Time dependence
  - Phosphorescence

## Appearance Taxonomy



## Rest of This Tutorial



- A Review of Radiometry & Physical Models – *Rusinkiewicz*
- Principles of Acquisition – *Zickler*
- (Spatially Varying) BRDF Models – *Lawrence*
- From BSSRDFs to 8D Reflectance Fields – *Lensch*
- The Human Face Scanner Project – *Weyrich*
- Future Directions / Q&A

## Principles of Acquisition

Todd Zickler  
Harvard University

SIGGRAPH 2008 Class

Los Angeles, August, 2008

## Outline

1. 5D: Homogeneous Reflectance (BRDF)
2. 7D: Spatially-varying Reflectance (SV-BRDF)
3. 9D: Subsurface Scattering (BSSRDF)
4. Calibration
5. Open problems

## Balancing Needs

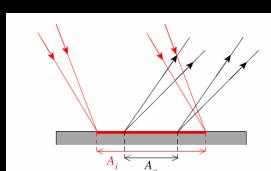
1. (Per-object) Acquisition Time
2. Accuracy and Precision
3. Cost
4. Generality: how broad is the class of surfaces being considered?

## Homogeneous Reflectance

- BRDF: Five dimensional domain  
 $f(\lambda, \vec{\omega}_i, \vec{\omega}_o) = f(\lambda, \theta_i, \phi_i, \theta_o, \phi_o)$
- Isotropic BRDF: Four dimensional domain  
 $f(\lambda, \theta_i, \theta_o, |\phi_i - \phi_o|)$

## BRDF: Measurement Scale

- One measures *averages* of the BRDF over finite intervals of surface area and solid angle.
- The measurement scale must be appropriate for the BRDF model to be valid (more on this later).



## The Gonioreflectometer

Four-axis gonioreflectometer

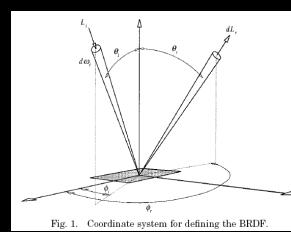
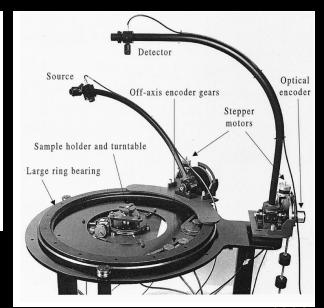


Fig. 1. Coordinate system for defining the BRDF.



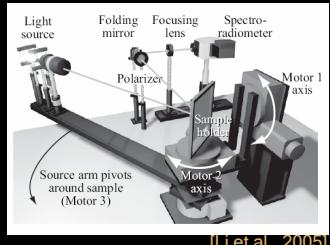
[White et al., 1998]

## The Gonioreflectometer

SIGGRAPH2008

### Three-axis gonioreflectometer

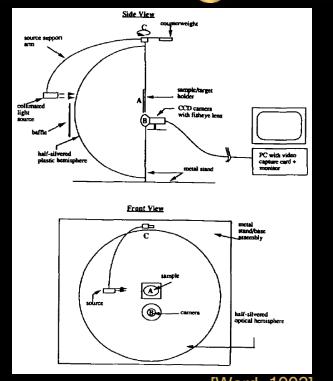
- Isotropic BRDF
- 1000 angular samples
- 31 spectral samples
- ~10 hours per BRDF



## Image-based measurement: planar

SIGGRAPH2008

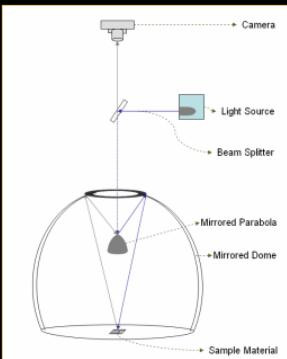
- Camera: Observe multiple output angles simultaneously
- Trade precision (and accuracy?) for efficiency



## Image-based measurement: planar

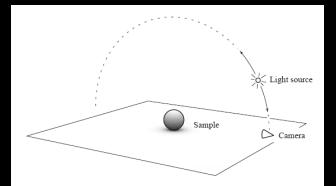
SIGGRAPH2008

SIGGRAPH2008



## Image-based measurement: curved

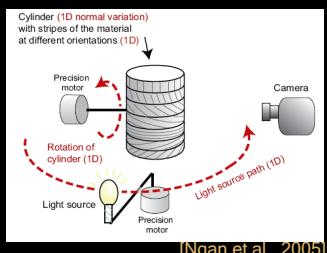
SIGGRAPH2008



## Image-based measurement: curved

SIGGRAPH2008

SIGGRAPH2008



## Image-based measurement: general

SIGGRAPH2008



## Outline



1. 5D: Homogeneous Reflectance (BRDF)
2. 7D: Spatially-varying Reflectance (SV-BRDF)
3. 9D: Subsurface Scattering (BSSRDF)
4. Calibration
5. Open problems

## Spatially-varying Reflectance

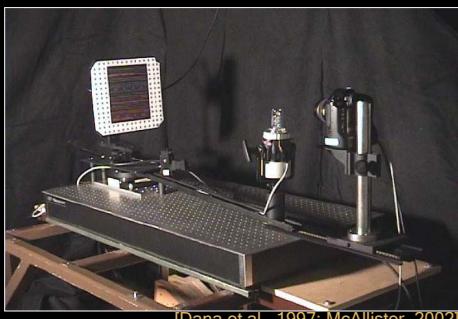


- SV-BRDF: Seven dimensional domain
$$f(\lambda, \vec{x}, \vec{\omega}_i, \vec{\omega}_o) = f(\lambda, x, y, \theta_i, \phi_i, \theta_o, \phi_o)$$
- Isotropic SV-BRDF: Six dimensional domain
$$f(\lambda, x, y, \theta_i, \theta_o, |\phi_i - \phi_o|)$$

## Planar Surfaces: The Spatial Gonioreflectometer



Three-axis spatial gonioreflectometer

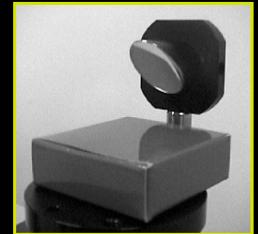
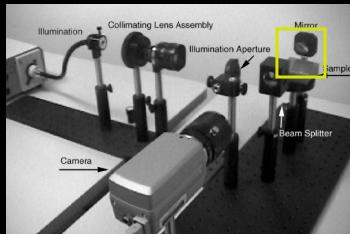


[Dana et al., 1997; McAllister, 2002]

## Planar Surfaces: Another Spatial Gonioreflectometer



- Can use catadioptrics to re-sort light rays and exchange spatial and angular resolution.

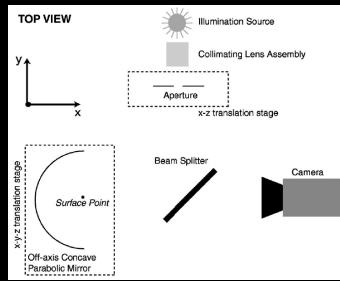
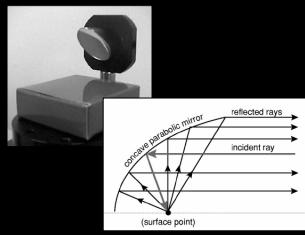


[Dana et al., 2004]

## Planar Surfaces: Another Spatial Gonioreflectometer



- Can use catadioptrics to re-sort light rays and exchange spatial and angular resolution.



[Dana et al., 2004]

## Curved Surfaces



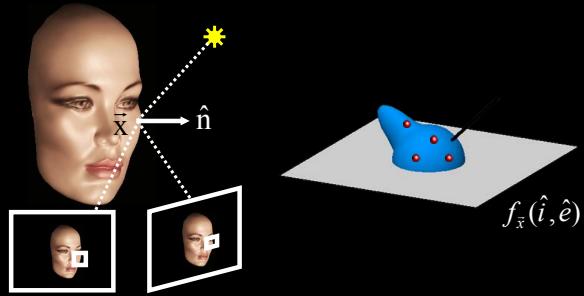
- Many interesting surfaces are not planar.
- Non-planar shapes can be used, provided the shape is known.



[Stanford Spherical Gantry  
(also Cornell, UVA, UCSD,...)]

## Counting Images

SIGGRAPH2008



5° sampling:	1,000,000 images	>10 <sup>6</sup> MB
1° sampling:	625,000,000 images	>10 <sup>9</sup> MB

## Counting Images

SIGGRAPH2008

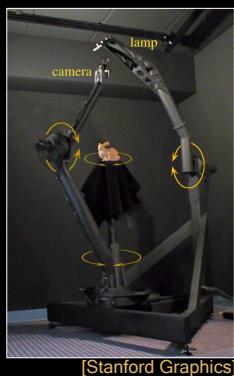
Reduce acquisition time by:

1. Designing efficient acquisition systems
2. Using parametric BRDF models
3. Exploiting common reflectance phenomena

5° sampling:	1,000,000 images	>10 <sup>6</sup> MB
1° sampling:	625,000,000 images	>10 <sup>9</sup> MB

## Acquisition Systems

SIGGRAPH2008



[Stanford Graphics]



[USC-ICT]

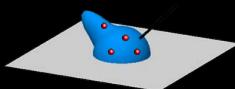


[MERL]

## Parametric Approaches

SIGGRAPH2008

- Pro: requires estimating only a handful of parameters at each surface point.
- Con: requires choice of specific parametric family (Oren-Nayar, Cook-Torrance, Phong,...)



$$f_{\vec{x}}(\hat{i}, \hat{e}) \leftarrow f_{\vec{x}}(\vec{\alpha}_{\vec{x}}; \hat{i}, \hat{e})$$

## Parametric Approaches

SIGGRAPH2008

- Some parametric approaches:
  - [Sato, Wheeler, Ikeuchi, 1997]
  - [Yu et al., 1999]
  - [Boivin, Gagalowicz, 2001]
  - [Lensch, et al., 2001]
  - [McAllister, Lastra, Heidrich, 2002]
  - [Georgiadis, 2003]
  - [Goldman et al., 2005]
  - ...

## General Reflectance Properties

SIGGRAPH2008

- Isotropy: from a 6D domain to 5D
- Reciprocity: cuts the angular domain in half
- Compressibility: BRDF is slowly varying over much of its angular domain
- Separability: distinct diffuse and specular components
- Spatial smoothness: slow variation from point to point
- Spatial regularity: a common per-object BRDF basis

## General Reflectance Properties



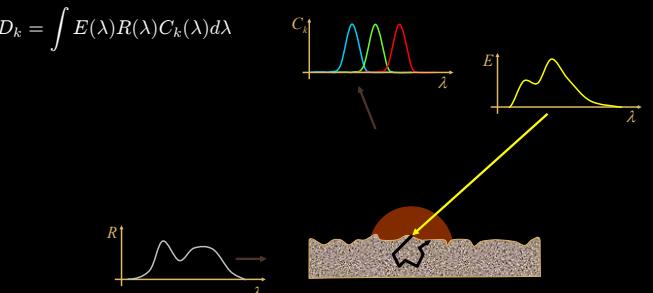
- Isotropy, reciprocity, separability are commonly exploited
- Compressibility
  - Implicit in parametric approaches; used in non-parametric approaches as well
- Spatial smoothness
  - Exploited in parametric (e.g., [Sato, Wheeler, Ikeuchi, 1997]) and non-parametric (e.g., [Zickler et al., 2006]) approaches
- Spatial regularity
  - Exploited in parametric (e.g., [Lensch et al., 2001], [Goldman et al. 2005]) and non-parametric (e.g., [Lawrence et al., 2006]) approaches

## Separability (Dichromatic Model)



$$\mathbf{I}_{RGB} = (\hat{\mathbf{n}} \cdot \hat{\mathbf{i}}) \mathbf{D}$$

$$D_k = \int E(\lambda) R(\lambda) C_k(\lambda) d\lambda$$



[Shafer, 1985]

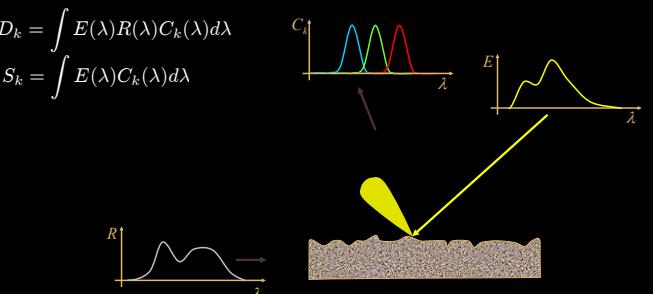
## Separability (Dichromatic Model)



$$\mathbf{I}_{RGB} = (\hat{\mathbf{n}} \cdot \hat{\mathbf{i}}) \mathbf{D} + f(\hat{\mathbf{n}}, \hat{\mathbf{i}}, \hat{\mathbf{v}}) \mathbf{S}$$

$$D_k = \int E(\lambda) R(\lambda) C_k(\lambda) d\lambda$$

$$S_k = \int E(\lambda) C_k(\lambda) d\lambda$$



[Shafer, 1985]

## “Separable” Materials

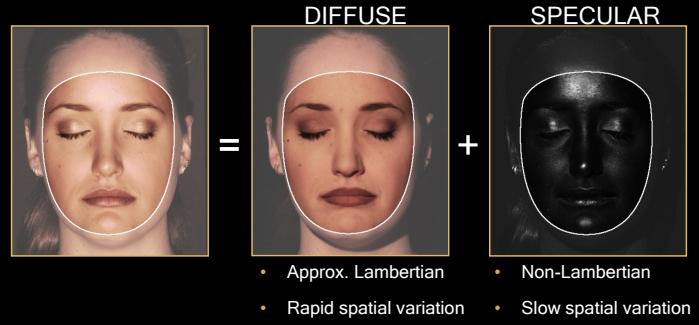


### “Separable” Materials



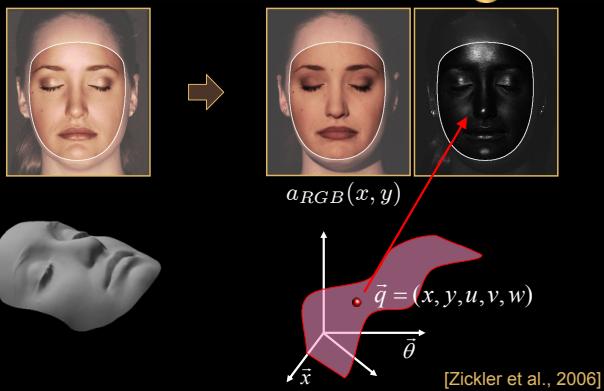
[Tominga and Wandell, 1989; Healey, 1989; Lee et al., 1990]

## Implications for Acquisition



## Example: Reflectance Sharing

SIGGRAPH2008

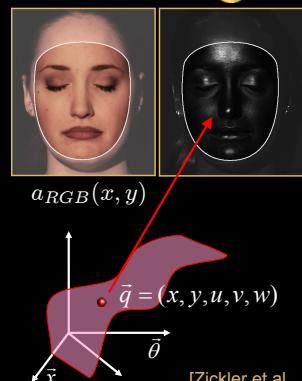


## Example: Reflectance Sharing

SIGGRAPH2008

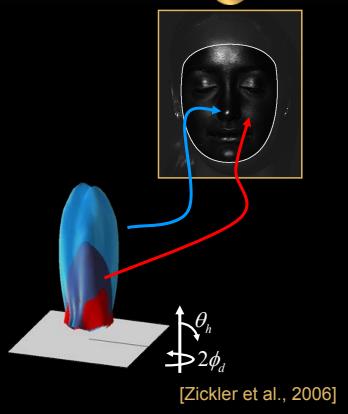
### Exploits:

- Separability
- Isotropy/Reciprocity
- Compressibility
- Slow spatial variation



## Example: Reflectance Sharing

SIGGRAPH2008



## Outline

SIGGRAPH2008

1. 5D: Homogeneous Reflectance (BRDF)
2. 7D: Spatially-varying Reflectance (SV-BRDF)
3. 9D: Subsurface Scattering (BSSRDF)
4. Calibration
5. Open problems

## Subsurface Scattering

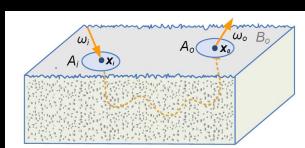
SIGGRAPH2008

### BSSRDF:

$$S(\lambda, \vec{x}_i, \vec{\omega}_i, \vec{x}_o, \vec{\omega}_o)$$

### Homogeneous, multiple scattering:

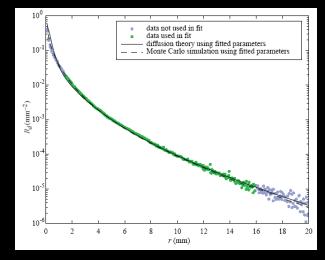
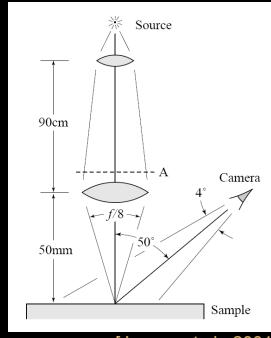
$$F_t(\eta, \vec{\omega}_i) R(\lambda, ||\vec{x}_i - \vec{x}_o||) F_t(\eta, \vec{\omega}_o)$$



## BSSRDF

SIGGRAPH2008

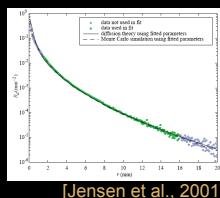
$$F_t(\eta, \vec{\omega}_i) R(\lambda, ||\vec{x}_i - \vec{x}_o||) F_t(\eta, \vec{\omega}_o)$$



[Jensen et al., 2001]

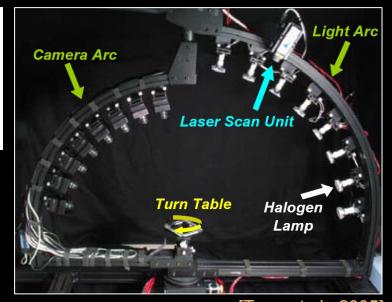
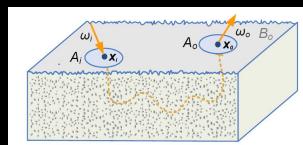
## BSSRDF

Material	$\sigma_s$ [mm $^{-1}$ ]			$\sigma_a$ [mm $^{-1}$ ]			Diffuse Reflectance			$\eta$
	R	G	B	R	G	B	R	G	B	
Apple	2.29	2.39	1.97	0.0030	0.0034	0.04	0.85	0.84	0.53	1.3
Chicken1	0.15	0.21	0.38	0.015	0.077	0.19	0.31	0.15	0.10	1.3
Chicken2	0.19	0.25	0.32	0.018	0.088	0.20	0.32	0.16	0.10	1.3
Cream	7.38	5.47	3.12	0.0002	0.0028	0.0163	0.98	0.90	0.73	1.3
Ketchup	0.18	0.07	0.03	0.001	0.09	0.45	0.16	0.09	0.00	1.3
Marble	2.19	2.62	3.00	0.0021	0.0041	0.0071	0.85	0.79	0.75	1.5
Milk	0.68	1.70	3.55	0.0024	0.0090	0.12	0.27	0.42	0.21	1.3
Skinmilk	0.70	1.22	1.90	0.0014	0.0035	0.0142	0.81	0.81	0.69	1.3
Skin1	0.74	0.88	1.01	0.032	0.17	0.48	0.44	0.22	0.13	1.3
Skin2	1.09	1.59	1.79	0.013	0.070	0.145	0.63	0.44	0.34	1.3
Spectralon	11.6	20.4	14.9	0.00	0.00	0.00	1.00	1.00	1.00	1.3
Wholenmilk	2.55	3.21	3.77	0.0011	0.0024	0.014	0.91	0.88	0.76	1.3



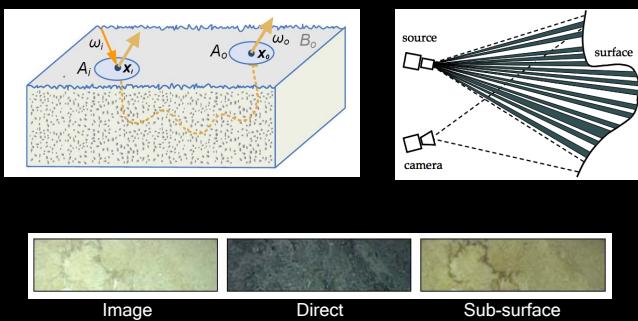
## BSSRDF

$$S(\lambda, \vec{x}_i, \vec{\omega}_i, \vec{x}_o, \vec{\omega}_o) = f_i(\vec{\omega}_i) R_d(\vec{x}_i, \vec{x}_o) f_o(\vec{x}_o, \vec{\omega}_o)$$



## Direct/Sub-surface Separation

SIGGRAPH2008



## Outline

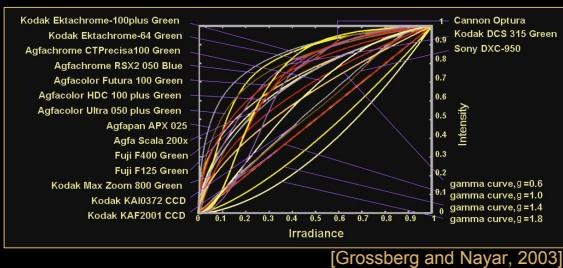
SIGGRAPH2008

1. 5D: Homogeneous Reflectance (BRDF)
2. 7D: Spatially-varying Reflectance (SV-BRDF)
3. 9D: Subsurface Scattering (BSSRDF)
4. Calibration
5. Open problems

## Radiometric Calibration

SIGGRAPH2008

- Camera:
  - Response function and high dynamic range (HDR) imaging



## Radiometric Calibration

SIGGRAPH2008

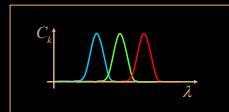
- Camera:
  - Response function and high dynamic range (HDR)
  - Optical fall-off



## Radiometric Calibration



- Camera:
  - Response function and high dynamic range (HDR)
  - Optical fall-off
  - Spectral filters



## Radiometric Calibration



- Camera:
  - Response function and high dynamic range (HDR)
  - Optical fall-off
  - Spectral filters
  - Thermal noise (at least)

## Radiometric Calibration



- Light source(s):
  - Temporal variation
  - Angular non-uniformity
  - Spectral power distribution
- Projector(s):
  - Optical fall-off
  - Spectral filters

## Geometric Calibration



- Camera/projector parameters (intrinsic/extrinsic)
- Source direction
- Surface Shape. Ideally:
  - Surface normals (Photometric stereo; Helmholtz stereo)
  - Independent of reflectance
  - Same images used for shape and reflectance



[Debevec et al., 2007]

## Some Open Problems



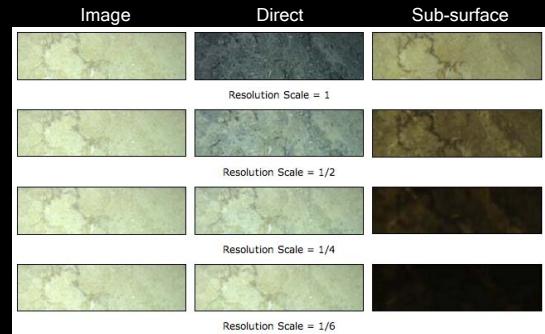
- Automatic scale selection



## Some Open Problems



- Automatic scale selection

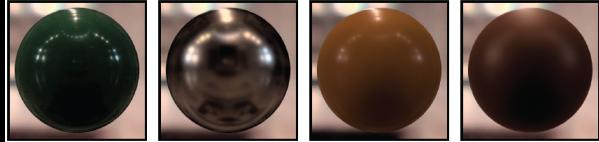


[Nayar et al., 2006]

## Some Open Problems



- Automatic scale selection
- Acquisition (inference) in complex lighting environments. [Dror 2001, Ramamoorthi and Hanrahan 2001]



## Some Open Problems



- Automatic scale selection
- Acquisition (inference) in complex lighting environments. [Dror 2001, Ramamoorthi and Hanrahan 2001]
- SV-BRDF acquisition as an inference problem. What are the priors?
- Increased spectral resolution
- Combined shape and reflectance acquisition

# Spatially-Varying BRDF Models

Jason Lawrence  
University of Virginia

## A Spatially-Varying BRDF



$$S(u, v, \omega_i, \omega_o)$$

## A Spatially-Varying BRDF



## Talk Outline

- acquisition
- representations
- future directions

## Acquisition



## Acquisition



# Outline



- acquisition
- representations
- future directions

# Representation



- goals
  - compact
  - editable
  - sampling
- challenges
  - scattered data
  - dimensionality
  - massive datasets

# Representation

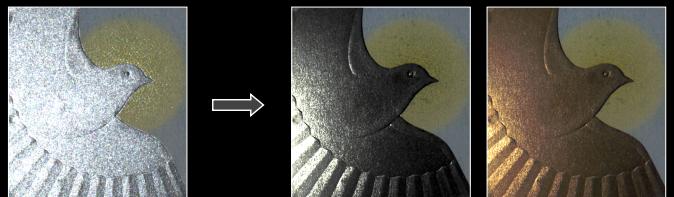


- goals
  - compact
  - editable
  - sampling
- challenges
  - scattered data
  - dimensionality
  - massive datasets

# Goal



- input: large set of reflectance measurements
- representation that is **compact** and **editable**



input measurements  
(1000s of images)

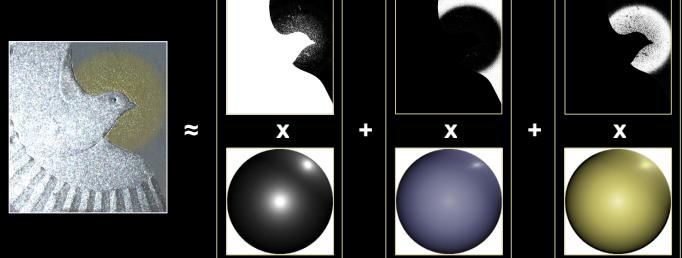
result of editing  
material properties

# Strategy: Basis Decomposition



$$S(u, v, \omega_i, \omega_o, \lambda) \approx \sum_{k=1}^K T_k(u, v) \rho_k(\omega_i, \omega_o, \lambda)$$

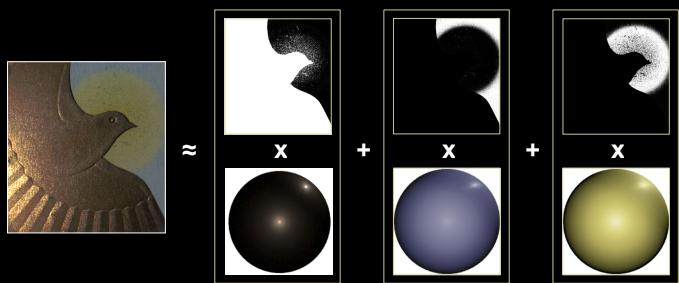
# Strategy: Basis Decomposition



$$S(u, v, \omega_i, \omega_o, \lambda) \approx \sum_{k=1}^K T_k(u, v) \rho_k(\omega_i, \omega_o, \lambda)$$

## Strategy: Basis Decomposition

SIGGRAPH2008



$$S(u, v, \omega_i, \omega_o, \lambda) \approx \sum_{k=1}^K T_k(u, v) \rho_k(\omega_i, \omega_o, \lambda)$$

## General Strategy

SIGGRAPH2008

- parametric
  - fit parametric BRDF model
  - cluster
  - reproject onto basis
- non-parametric
  - tabulate the reflectance data
  - cast as matrix factorization
  - place constraints on factors

## Acquisition

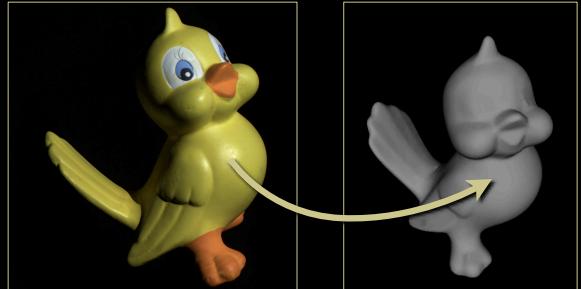
SIGGRAPH2008



Lensch, H., Kautz, J., Goesele, M., Heidrich, W., Seidel, H.-P.  
Image-Based Reconstruction Spatial Appearance  
ACM Transactions on Graphics 22(3), 2003

## Registration

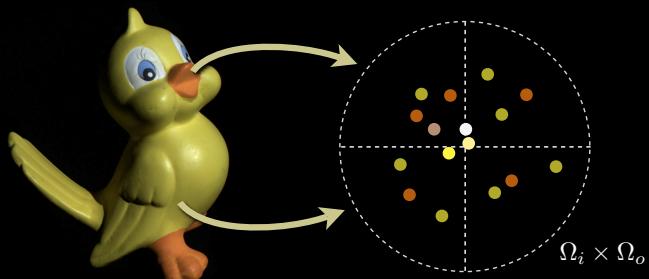
SIGGRAPH2008



silhouette-based alignment procedure

## Fitting Lafortune Parameters

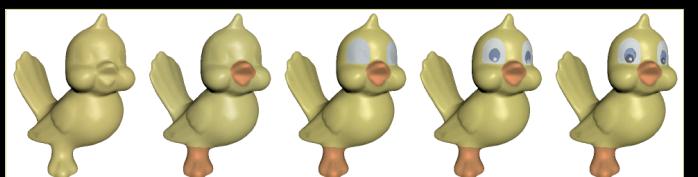
SIGGRAPH2008



$$\rho(\vec{l}, \vec{v}) = k_d + \sum_i [C_{x,i}(l_x v_x + l_y v_y) + C_{z,i} l_z v_z]^{N_i}$$

## Clustering

SIGGRAPH2008

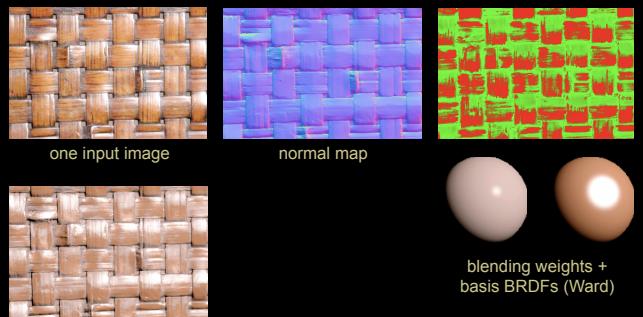


## Reprojection



SIGGRAPH2008

## Goldman et al. 2005



Goldman, D., Curless, B., Hertzmann, A., Seitz, S.  
Shape and Spatially Varying BRDFs from Photometric Stereo  
Proceedings of ICCV 2005.

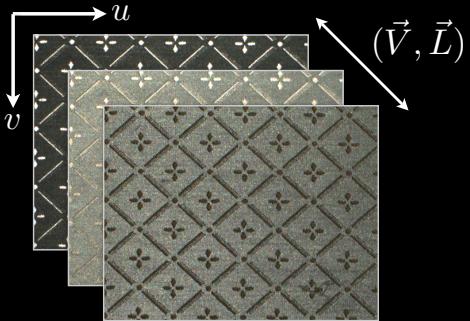
## General Strategy

SIGGRAPH2008

- parametric
  - fit parametric BRDF model
  - cluster
  - reproject onto basis
- non-parametric
  - tabulate the reflectance data
  - cast as matrix factorization
  - place constraints on factors

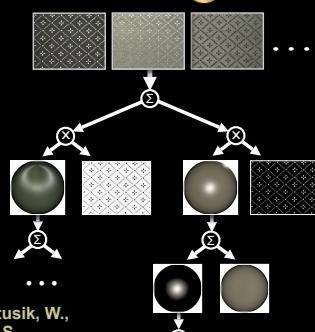
## Wallpaper Dataset

SIGGRAPH2008



## Inverse Shade Trees

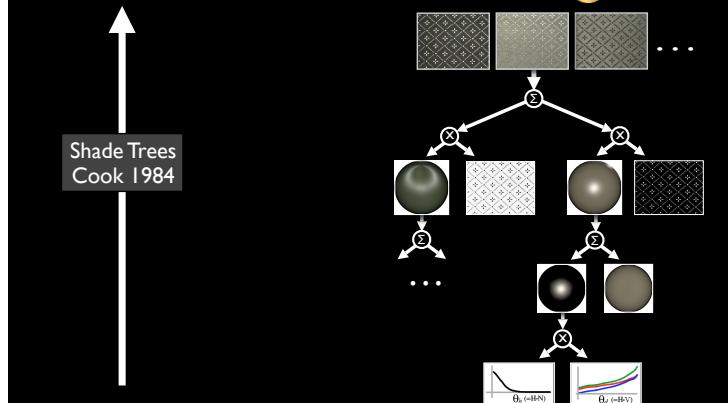
SIGGRAPH2008



Lawrence, J., Ben-Artzi, A., DeCoro, C., Matusik, W., Pfister, H., Ramamoorthi, R., Rusinkiewicz, S.  
Inverse Shade Tree Framework for Non-Parametric Material Representation and Editing  
Proceedings of SIGGRAPH 2006.

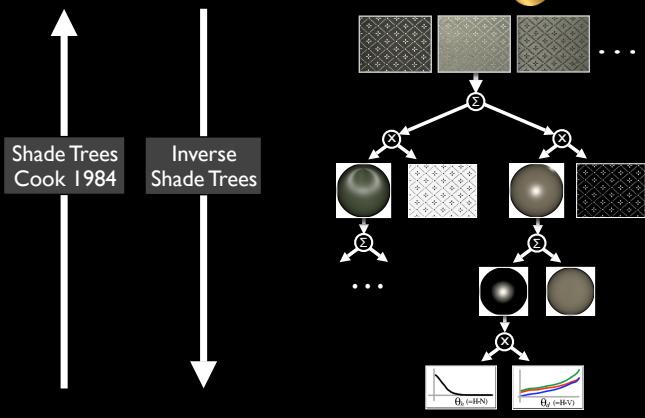
## Inverse Shade Tree Framework

SIGGRAPH2008



## Inverse Shade Tree Framework

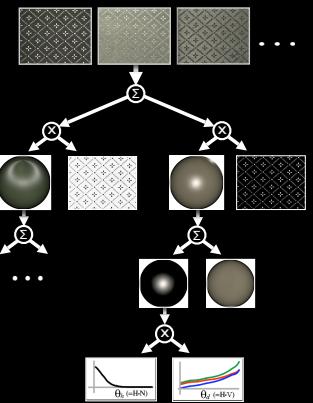
SIGGRAPH2008



## Inverse Shade Tree Framework

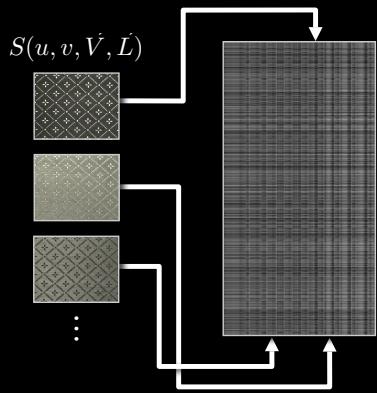
SIGGRAPH2008

decomposition at each level is cast as matrix factorization



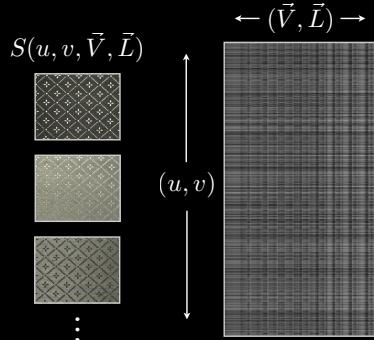
## Tabulate Raw Data

SIGGRAPH2008



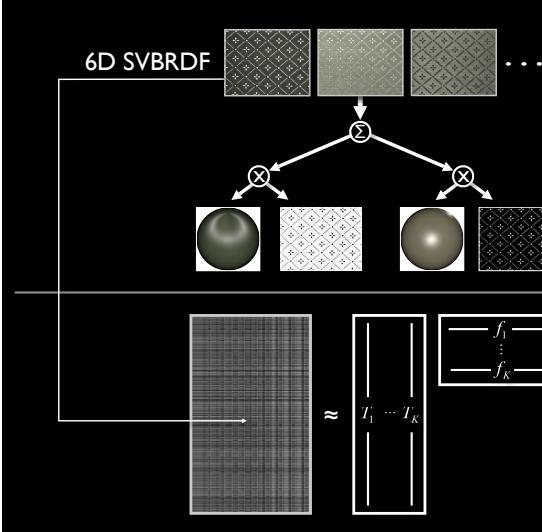
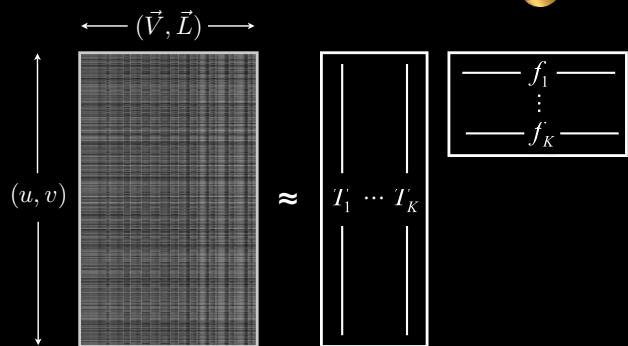
## Tabulate Raw Data

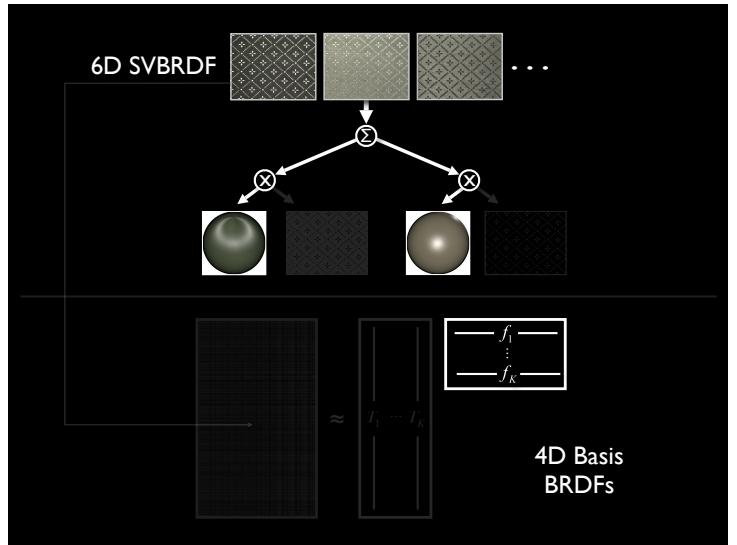
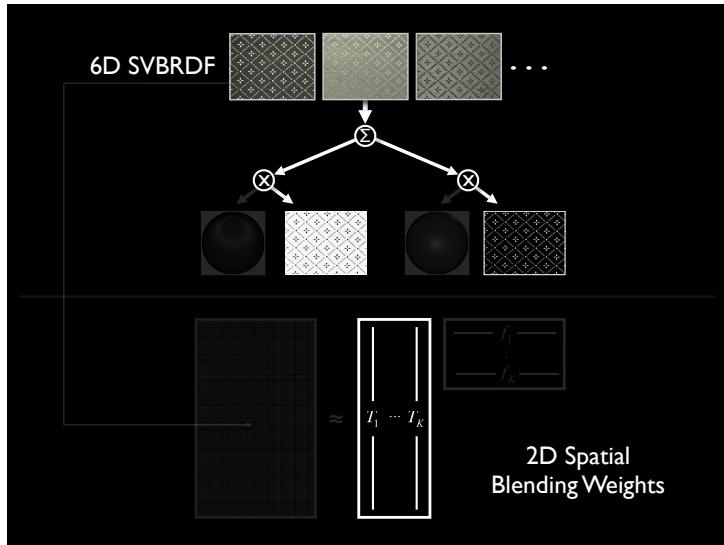
SIGGRAPH2008



## Factor SBRDF

SIGGRAPH2008





## Research Challenge

SIGGRAPH2008

providing an intuitive factorization:

$$\begin{array}{c|c|c} \text{grid} & \approx & \text{?} \\ \hline & \approx & ? \end{array}$$

## Key Idea

SIGGRAPH2008

incorporate domain-specific knowledge as constraints of factorization:

$$\begin{array}{c|c|c} \text{grid} & \approx & \text{plausible BRDFs} \\ \hline & \approx & \text{plausible blending weights} \end{array}$$

## Factorization Constraints

SIGGRAPH2008

- **non-negativity:** reflectance functions are non-negative
- **sparsity:** few BRDFs at each position
- **domain-specific:**
  - energy conservation, monotonicity, etc.

## Factorization Algorithms

SIGGRAPH2008

algorithm	properties			
	linear	positive	sparse	domain
PCA	✓	✗	✗	✗
clustering	✗	✓	✓	✗
NMF	✓	✓	✓	✗
ACLS	✓	✓	✓	✓

# Alternating Constrained LS

SIGGRAPH2008

$$\begin{bmatrix} V \\ W \end{bmatrix} \approx \begin{bmatrix} \vec{v} \\ \vec{w} \end{bmatrix} \begin{bmatrix} H \end{bmatrix}$$

1. Initialize  $W$  and  $H$
2. Update  $W$
3. Update  $H$
4. Iterate until convergence

# Alternating Constrained LS

SIGGRAPH2008

$$\begin{bmatrix} \vec{v} \\ \vec{w} \end{bmatrix} \approx \begin{bmatrix} \vec{w} \\ H \end{bmatrix}$$

convex QP problem

$$\min_{\vec{w}} \|\vec{v} - \vec{w}H\|^2$$

$$\vec{l} \leq \begin{Bmatrix} \vec{w}^T \\ A\vec{w}^T \end{Bmatrix} \leq \vec{u}$$

1. Initialize  $W$  and  $H$
2. Update  $W$
3. Update  $H$
4. Iterate until convergence

# Reflectance Constraints

SIGGRAPH2008

- **non-negativity**
  - constraint on value
- **energy conservation**
  - constraint on sum
- **monotonicity**
  - constraint on derivative

$$\vec{l} \leq \begin{Bmatrix} \vec{w}^T \\ A\vec{w}^T \end{Bmatrix} \leq \vec{u}$$

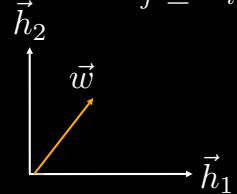
# Measure of Sparsity

SIGGRAPH2008

$$\begin{bmatrix} \vec{v} \\ \vec{w} \end{bmatrix} \approx \begin{bmatrix} \vec{w} \\ H \end{bmatrix}$$

$$E_{sparse} = \sum_{i \neq j} w_i$$

$$w_j \geq w_i, i = 1 \dots K$$



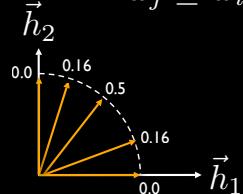
# Measure of Sparsity

SIGGRAPH2008

$$\begin{bmatrix} \vec{v} \\ \vec{w} \end{bmatrix} \approx \begin{bmatrix} \vec{w} \\ H \end{bmatrix}$$

$$E_{sparse} = \sum_{i \neq j} w_i$$

$$w_j \geq w_i, i = 1 \dots K$$



# Season's Greetings Dataset

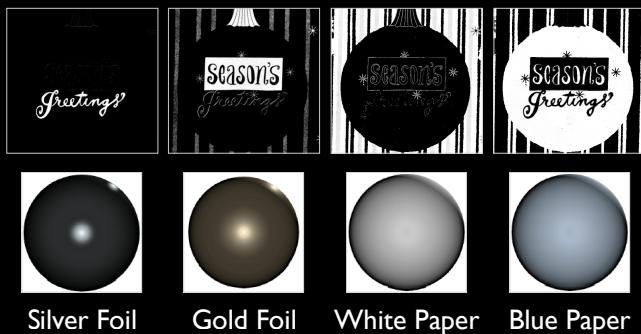
SIGGRAPH2008



# Season's Greetings Dataset



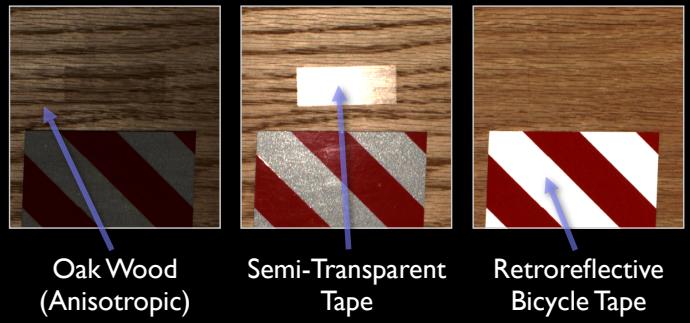
Factorization Computed with **ACLS** (4 Terms)



# Wood+Tape Dataset



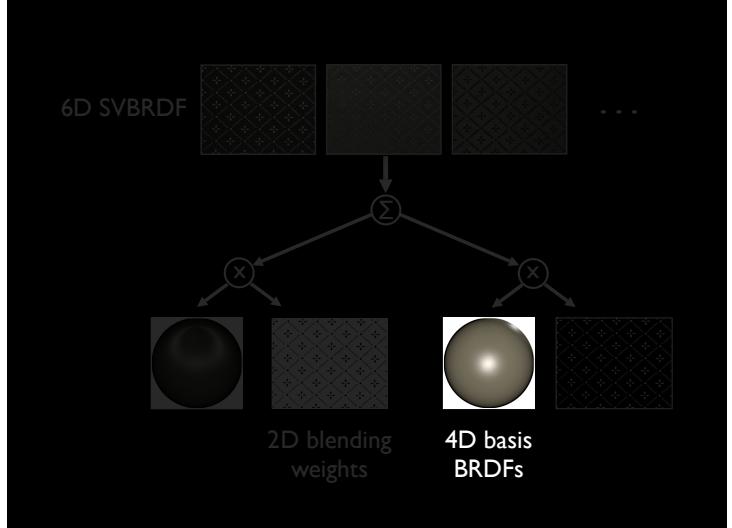
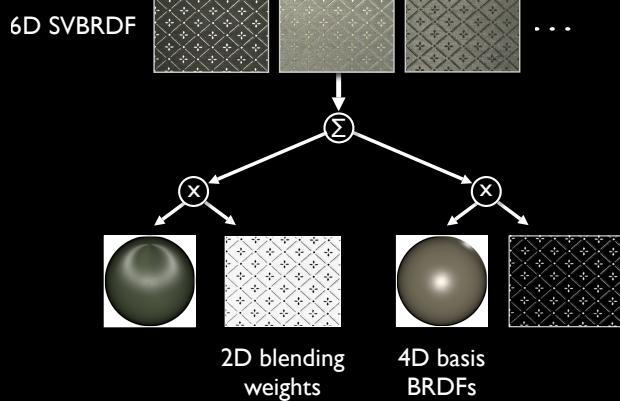
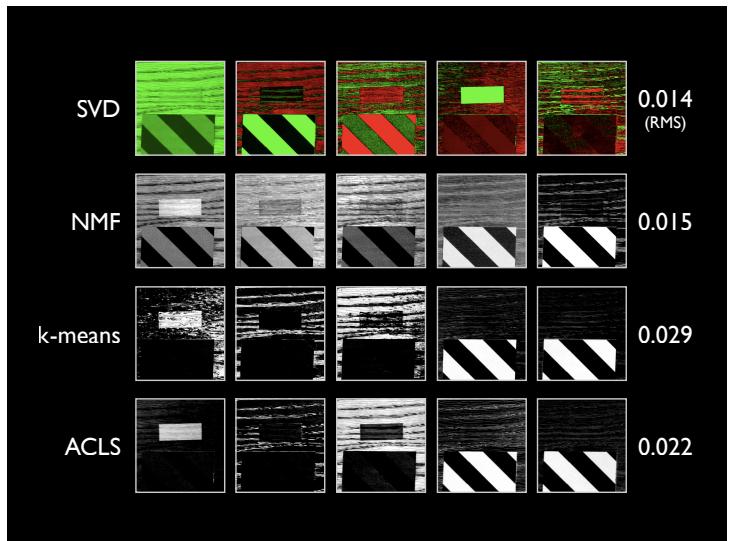
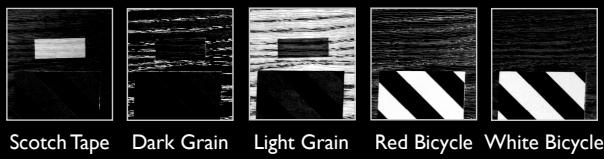
12 Camera Positions  $\times$  480 Light Positions = 6,000 Images

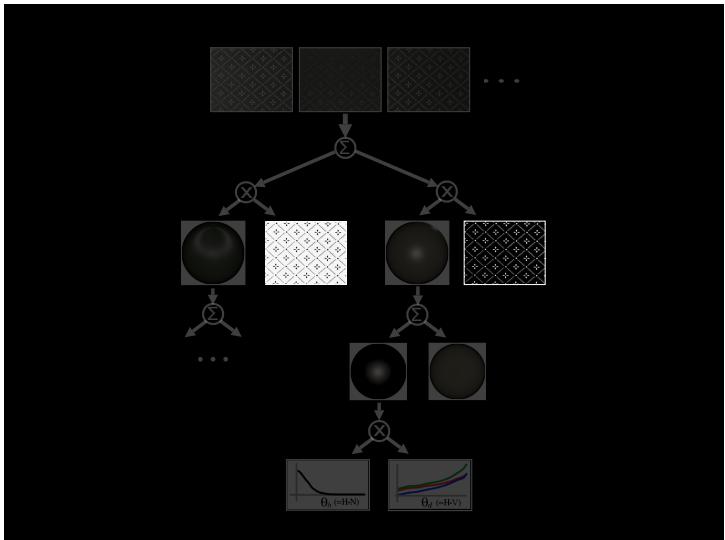
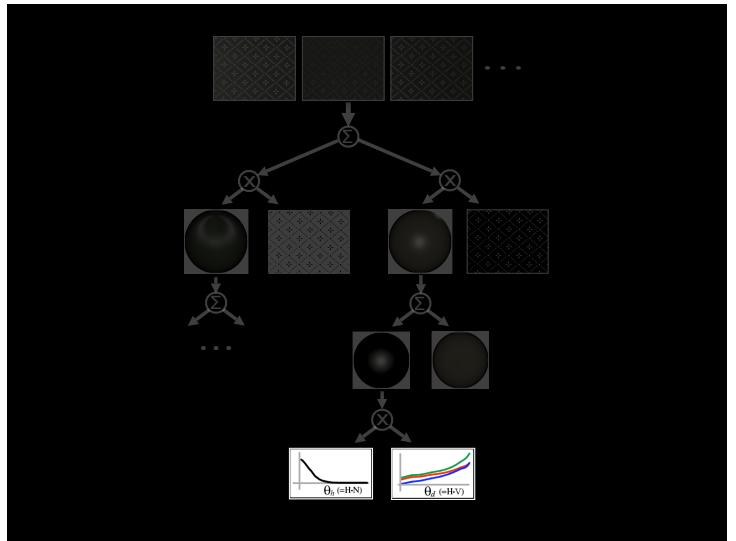
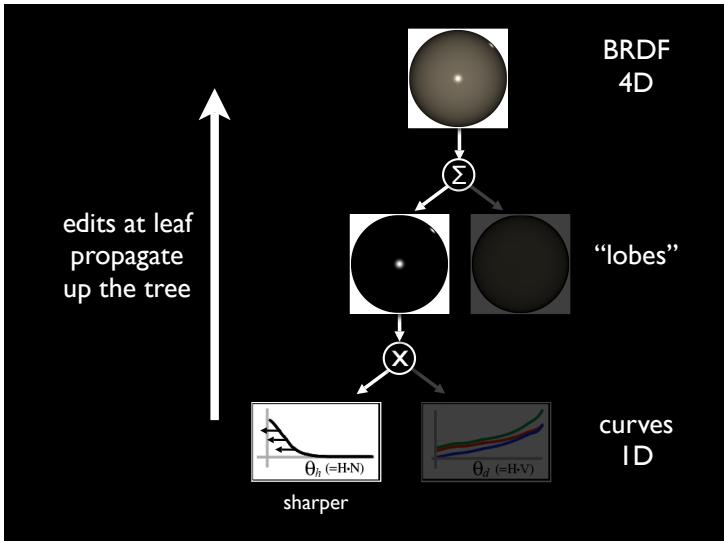
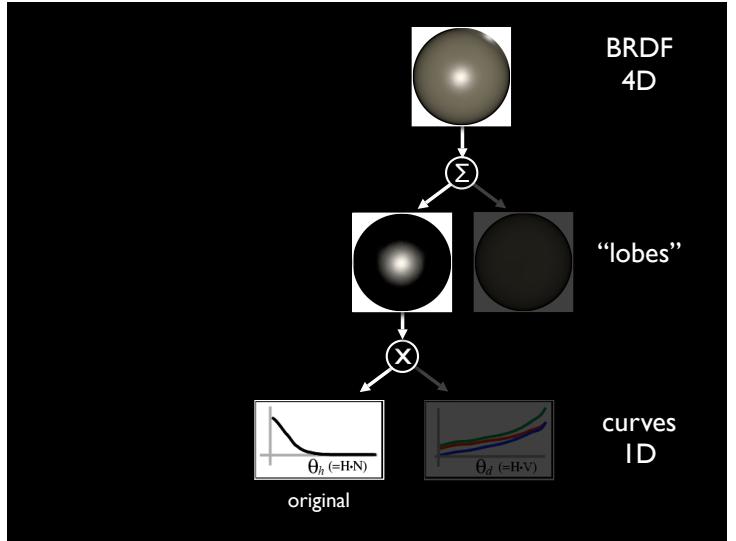
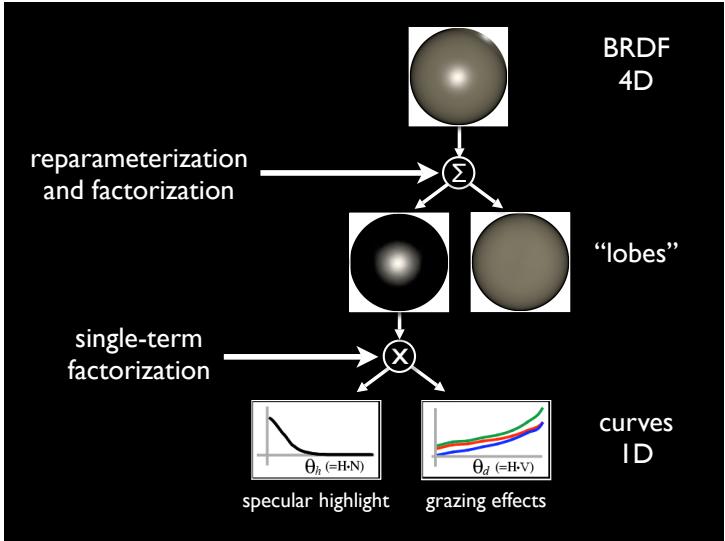


# Wood+Tape Dataset



Blending Weights from **ACLS** (5 Terms)





## Summary

- **representation goals:**
    - compact
    - editable
    - supports rendering
  - **basis decomposition**
    - parametric
    - non-parametric

## Summary



- sparse/scattered data
- interpolation
- flexibility
- local minima

## Summary



- sparse/scattered data
- interpolation
- flexibility
- local minima

## Summary



- sparse/scattered data
- interpolation
- flexibility/accuracy
- local minima

## Summary



- sparse/scattered data
- interpolation
- flexibility
- local minima

## Future Directions



- higher-dimensional datasets
  - subsurface scattering / reflectance field
  - time-varying properties
  - etc.
- rigorous probabilistic framework
- measurement
  - synchronous shape + appearance
  - lowering calibration burden

## Future Directions



- higher-dimensional datasets
  - subsurface scattering / reflectance field
  - time-varying properties
  - etc.
- rigorous probabilistic framework
- measurement
  - synchronous shape + appearance
  - lowering calibration burden

# Future Directions



- higher-dimensional datasets
  - subsurface scattering / reflectance field
  - time-varying properties
  - etc.
- rigorous probabilistic framework
- measurement
  - synchronous shape + appearance
  - lowering calibration burden

# Future Directions



- higher-dimensional datasets
  - subsurface scattering / reflectance field
  - time-varying properties
  - etc.
- rigorous probabilistic framework
- measurement
  - synchronous shape + appearance
  - lowering calibration burden

## From BSSRDFs to 8D Reflectance Fields

Hendrik P. A. Lensch  
MPI Informatik

SIGGRAPH 2008 Class

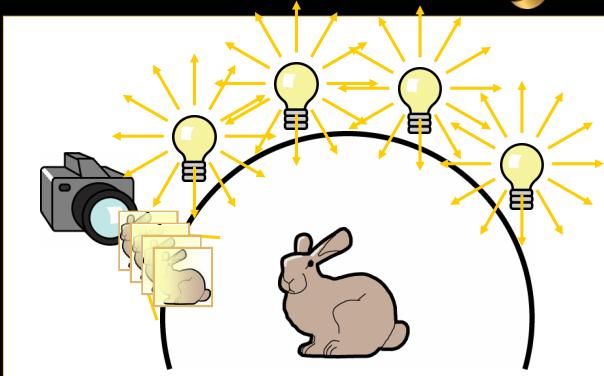
Los Angeles, August, 2008

## Digitizing Real World Objects



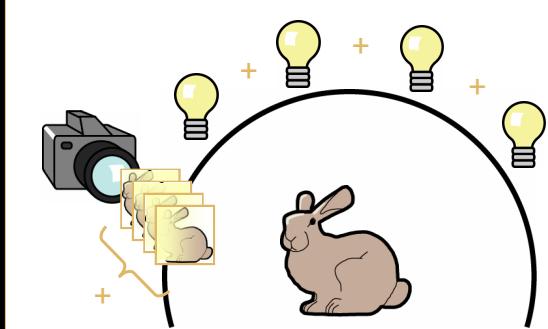
relighting with arbitrary illumination patterns

### Relighting



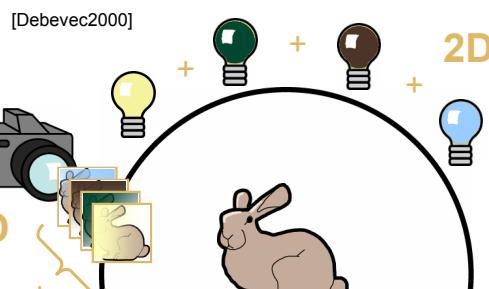
one image for each light direction

### Relighting



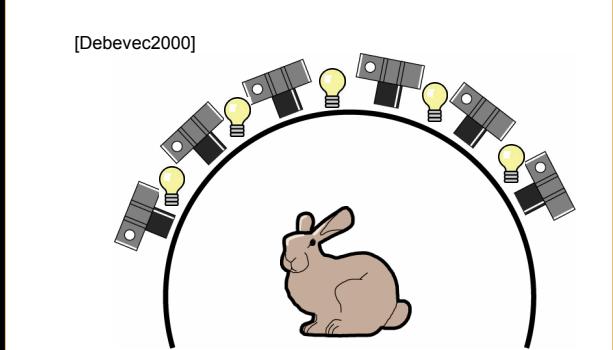
superposition

### Reflectance Fields



arbitrary materials, but single view point

### Reflectance Field – 6D

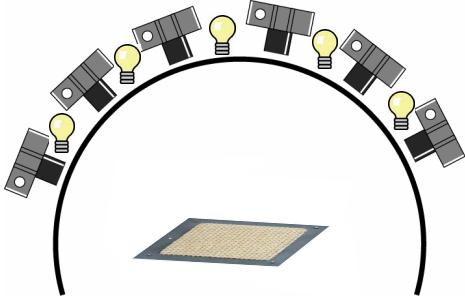


arbitrary materials, arbitrary geometry

## Bidirectional Texture Functions

SIGGRAPH2008

[Dana1997]



arbitrary materials, surface patch

## BTF Acquisition Devices

SIGGRAPH2008



[Sattler2003]

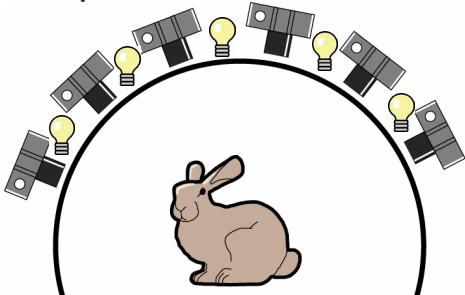


[Mueller2005]

## Far-Field Reflectance Fields

SIGGRAPH2008

[Debevec2000]



arbitrary materials, but distant light sources only

## Far- vs. Near-Field Illumination

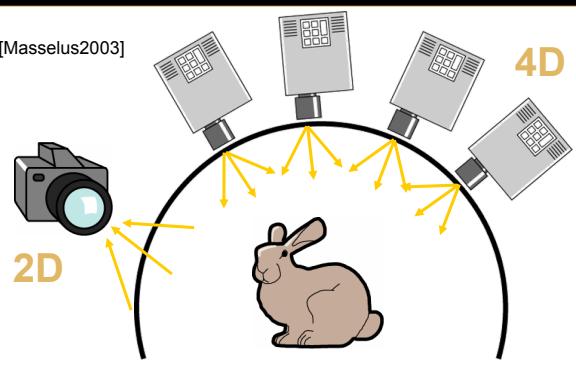
SIGGRAPH2008



## 6D Reflectance Fields

SIGGRAPH2008

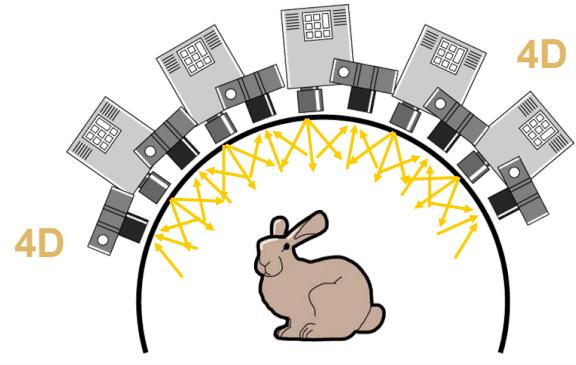
[Masselus2003]



relighting with 4D incident light fields

## 8D Reflectance Fields

SIGGRAPH2008



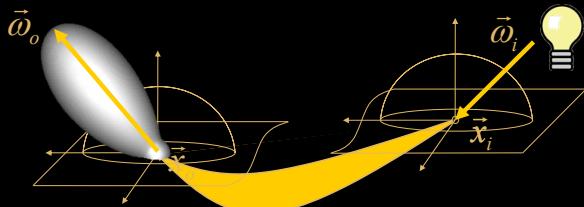
arbitrary materials +  
arbitrary view point + arbitrary illumination

## Definition – Reflectance Field

8D function = BSSRDF



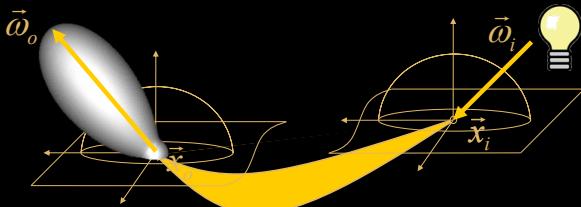
$$f_r((\vec{x}_i, \vec{\omega}_i) \rightarrow (\vec{x}_o, \vec{\omega}_o))$$



## Definition – Reflectance Field

ratio of reflected radiance to incident flux

$$f_r((\vec{x}_i, \vec{\omega}_i) \rightarrow (\vec{x}_o, \vec{\omega}_o)) = \frac{dL_o(\vec{x}_o, \vec{\omega}_o)}{d\phi_i(\vec{x}_i, \vec{\omega}_i)}$$



## Main Problem



- sampling an **8D function**
  - spending 100 samples/dimension  
→  $10^{16}$  samples
  - hi-res 3D geometry:  $10^8$  vertices
- coherence in reflectance fields  
→ reduced data complexity
- no complete solution yet



## Approaches



- limited reflectance model
- limited reproduction
  - viewer position
  - incident illumination
- adaptive parallel acquisition
- advanced interpolation

## Relighting with 4D Incident Light Fields



- goal: relighting with spatially varying illumination,  
e.g. spot lights



## Acquisition with Large Blocks



- fixed camera perspective
- rotating illumination

## Relighting Results



## Translucent Objects



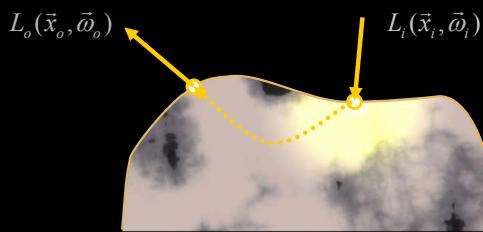
- light transport through the object
- scattering dampens high frequencies

## BSSRDF – 8D



bidirectional scattering-surface reflectance distribution function [Nicodemus77]

$$f_r((\vec{x}_i, \vec{\omega}_i) \rightarrow (\vec{x}_o, \vec{\omega}_o))$$

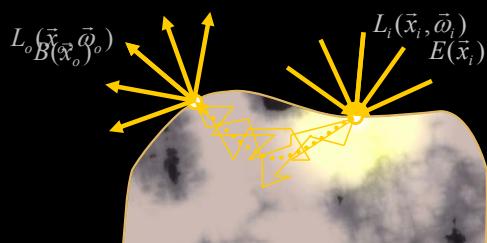


## Diffuse Approximation



neglect directional dependency [Jensen 2001]

- multiple scattering leads to diffuse light transport



## 4D - Diffuse Approximation



⇒ diffuse reflectance function  $R_d(\vec{x}_i, \vec{x}_o)$

- four dimensions only
- dense sampling is possible



## Diffuse Reflectance Function $R_d$



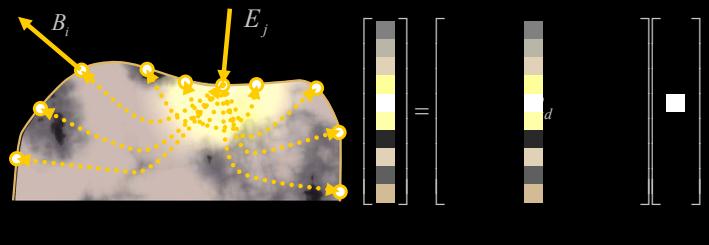
- discretize the surface
  - enumerate all surface points
  - vectors for irradiance  $E$  and radiosity  $B$
- matrix  $R_d$ 
  - linear point-to-point transport

$$\begin{bmatrix} B_i \\ \vdots \\ B_n \end{bmatrix} = \begin{bmatrix} R_d & & \\ & \ddots & \\ & & R_d \end{bmatrix} \begin{bmatrix} E_j \\ \vdots \\ E_n \end{bmatrix}$$

## Basic Idea



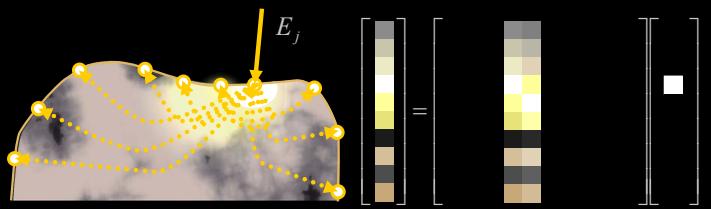
- direct measurement of  $R_d$ 
  - illuminate individual surface points
  - capture impulse response function



## Basic Idea



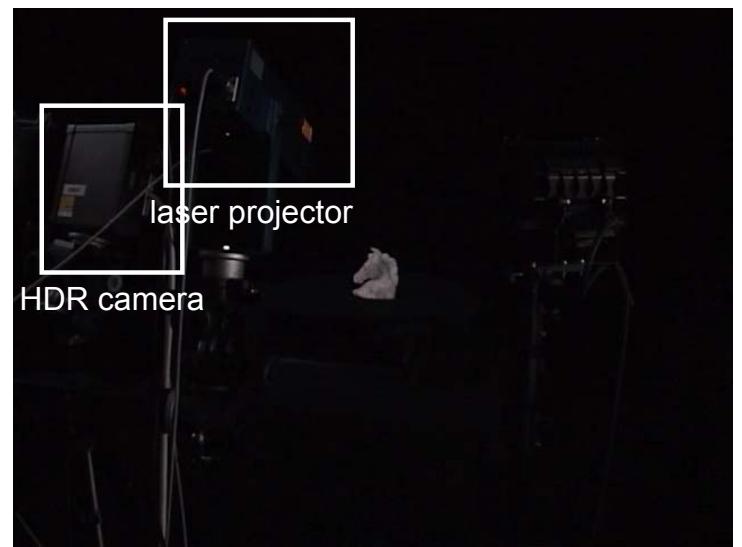
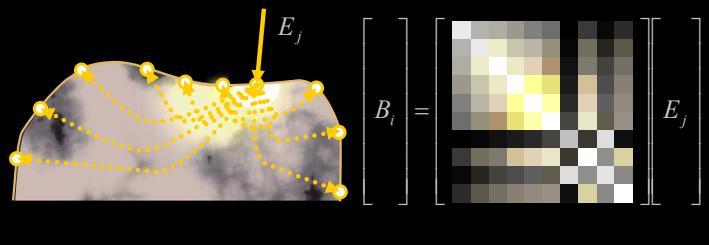
- direct measurement of  $R_d$ 
  - illuminate individual surface points
  - capture impulse response function



## Basic Idea



- direct measurement of  $R_d$ 
  - illuminate individual surface points
  - capture impulse response function



## Matrix Representation



- 500.000 - 1.000.000 input images  
 $\Rightarrow \sim 100.000^2$  entries
- fill up holes (inpainting)
- hierarchical representation
- hardware assisted rendering
  - analysis
  - real-time rendering

*[Lensch, Goesele, Bekaert, Magnor, Lang, Seidel – PG2003]*

## Video

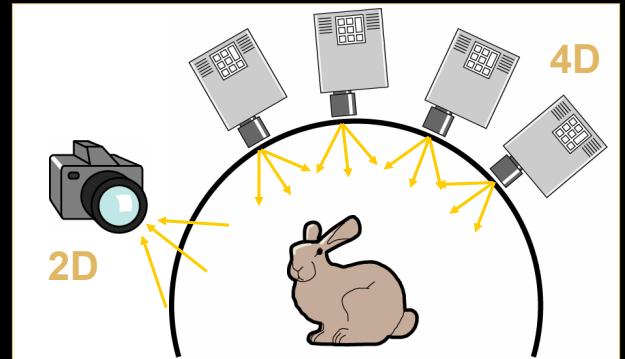
1.000.000 images, 22 hours → model - 800MB



[Goesele, Lensch, Lang, Fuchs, Seidel - SIGGRAPH 2004]

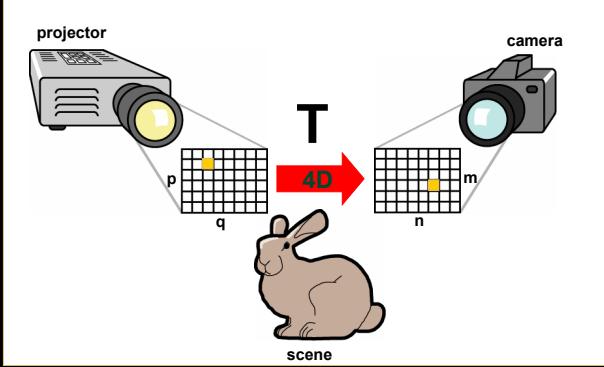
## Fixed Perspective + Arbitrary Illumination

SIGGRAPH2008



## Pixel-to-Pixel Transport

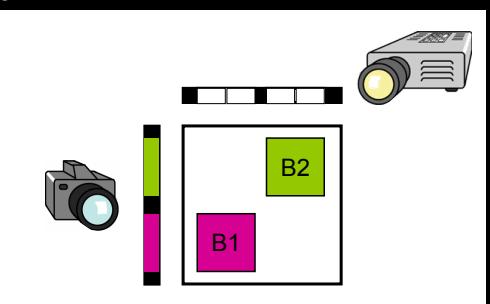
SIGGRAPH2008



## Adaptive Parallel Acquisition

SIGGRAPH2008

- assumption: sparse matrix
- radiometrically independent blocks can be sensed in parallel



## Adaptive Parallel Acquisition

SIGGRAPH2008

parallelized acquisition of regions which do not overlap in the camera image



projector pattern

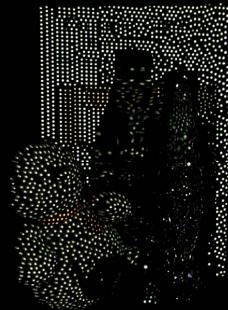


camera image

## Adaptive Parallel Acquisition

SIGGRAPH2008

parallelized acquisition of regions which do not overlap in the camera image



## Relighting with Arbitrary Patterns



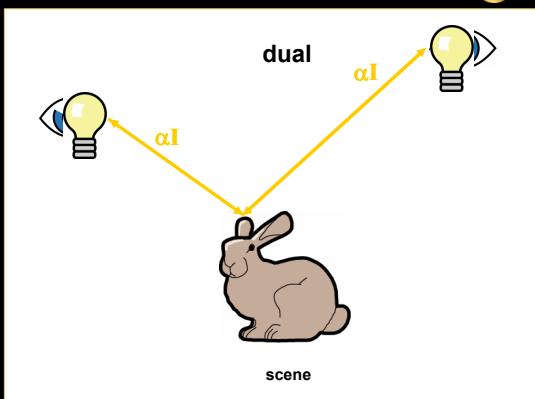
1.200 images. 2 hours → model - 220MB



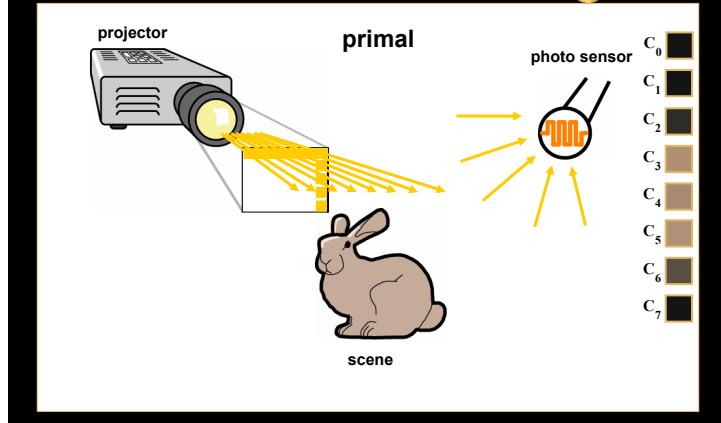
## Captured Global Light Transport



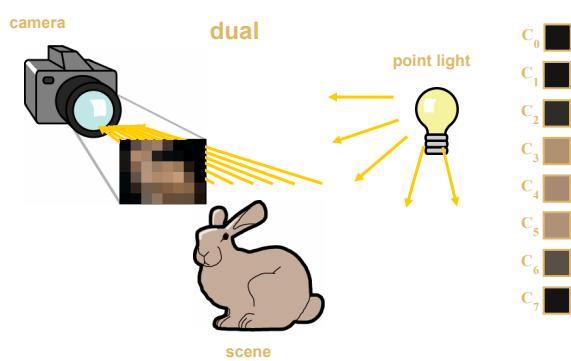
## Helmholtz Reciprocity



## Image Acquisition without a Camera



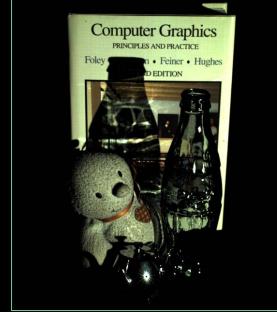
## Image Acquisition without a Camera



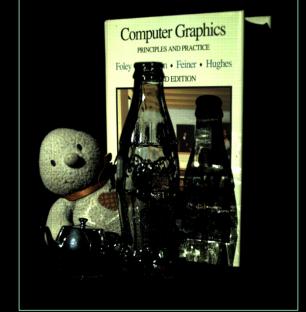
## Dual Photography



### photograph from camera



### dual image from projector



[Sen, Chen, Garg, Marschner, Horowitz, Levoy, Lensch - SIGGRAPH 2005]

## Examples

SIGGRAPH2008



primal

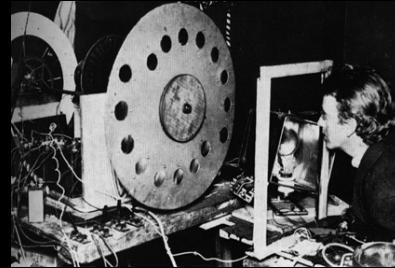


dual

## Related Techniques

SIGGRAPH2008

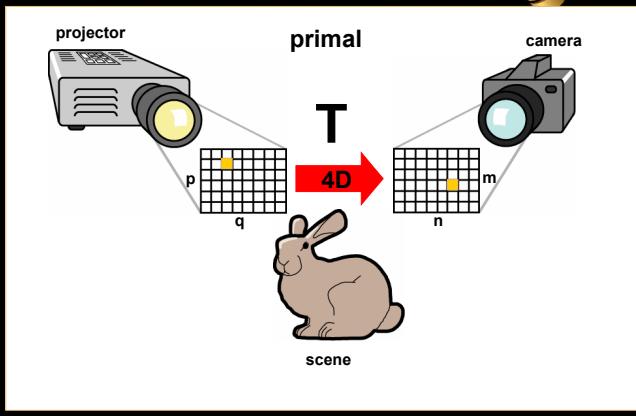
- “Flying-spot” TV camera [Baird 1926]
- scanning electron microscope



35x magnification  
[Museum of Science, Boston]

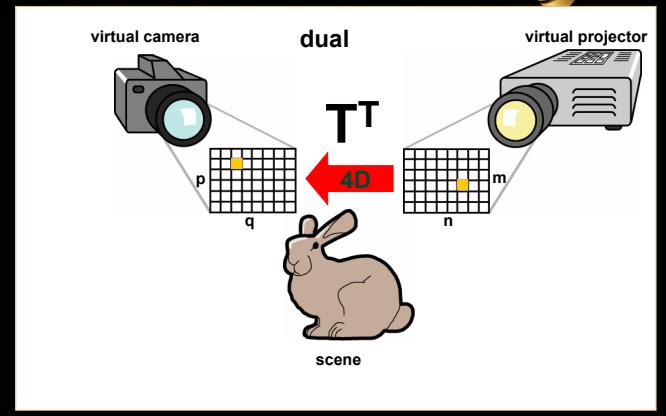
## Relighting with Dual Photography

SIGGRAPH2008



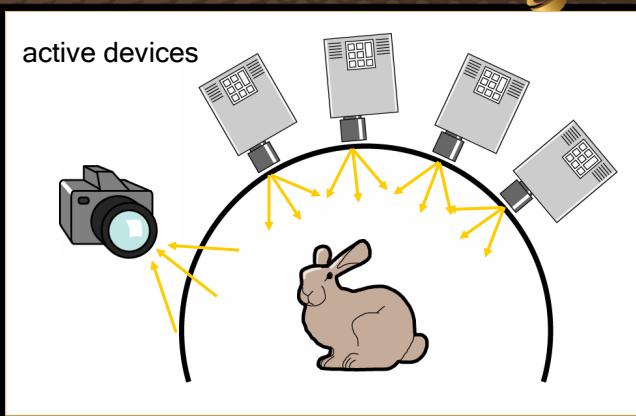
## Relighting with Dual Photography

SIGGRAPH2008



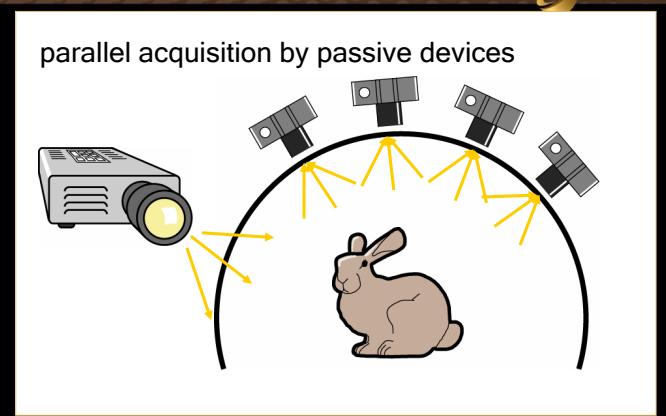
## Acquisition of 6D Reflectance Fields

SIGGRAPH2008



## Dual Acquisition Process

SIGGRAPH2008



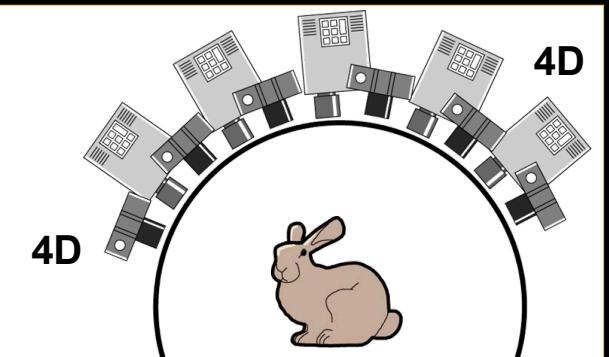
## Smooth Interpolation

100.000 images, 26 hours → model - 4.5GB



[Chen, Lensch - VMV2005]

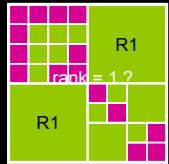
## 8D Reflectance Fields



arbitrary view point + arbitrary illumination

## $\mathcal{H}$ -Matrices

[Hackbusch2000]



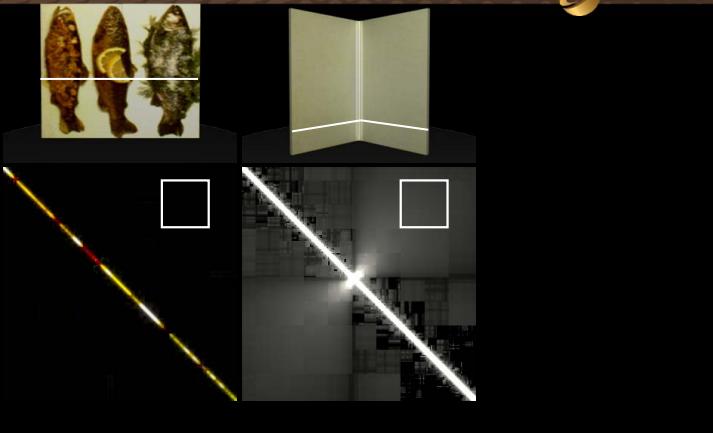
efficient representation of dense but  
***data-sparse*** matrices

- subdivision hierarchy
- local low-rank approximation
- efficient evaluation

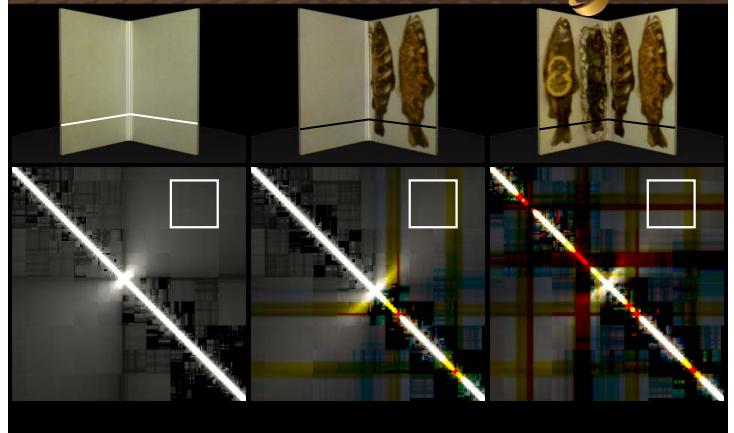
## Direct vs. Indirect Reflections



## Direct vs. Indirect Reflections



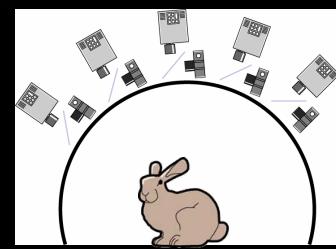
## Direct vs. Indirect Reflections



## 2D Slices through a Reflectance Field



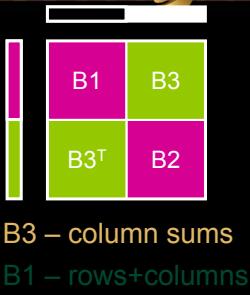
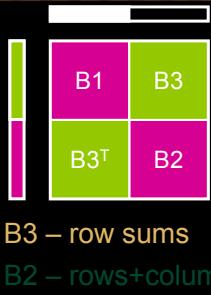
## Symmetric Acquisition



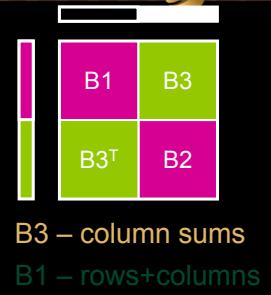
- symmetric 8<sup>th</sup> order tensor
- rank-1 approximation from two images only
- parallel acquisition of dense matrices

[Garg, Talvala, Levoy, Lensch – EGSR06]

## Symmetric Exploration



## Symmetric Exploration



rank-1 approximation?

$$B3 \approx \begin{matrix} | \\ | \end{matrix} \bullet \begin{matrix} | \\ | \end{matrix}$$

## Hierarchical Rank-1 Decomposition



$$\begin{matrix} B1 & R1 \\ R1 & B2 \end{matrix} = \begin{matrix} \square & B3 \\ B3^T & \square \end{matrix} + \begin{matrix} B1 & \square \\ \square & B2 \end{matrix} = \dots$$

already determined      radiometrically independent

B1 and B2 are investigated in parallel.

parallel acquisition even for dense matrices

## Dual vs. Symmetric Photography



- increased SNR because regions are determined at large block sizes

## An 8D Reflectance Field



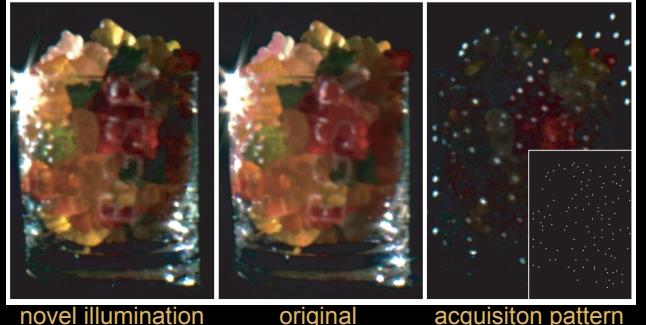
3.300 images, 6 hours → model - 1.4 GB



## Virtual Photography

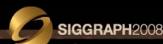


- reflectance fields of arbitrarily complex scenes

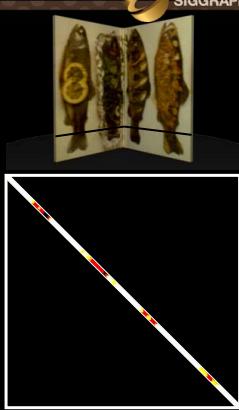


[Garg, Talvala, Levoy, Lenzsch – EGSR 2006]

## Application of Near-field Reflectance Fields



- getting rid of global effects



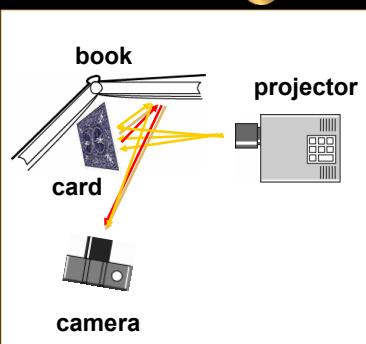
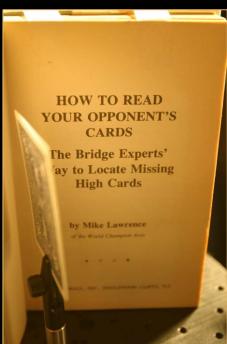
compare [Nayar2006]

## Application to 3D Scanning



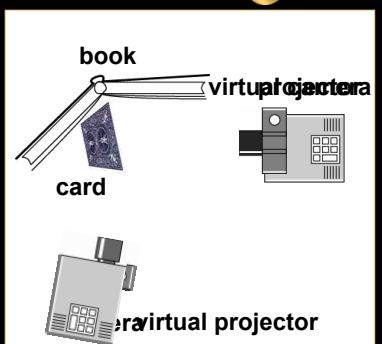
[Chen, Fuchs, Lenzsch, Seidel – CVPR 2007]

## Card Experiment



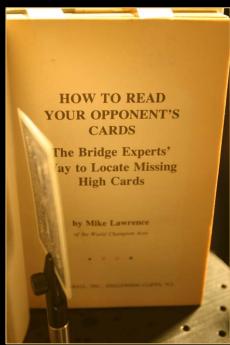
primal

## Card Experiment



primal

## Card Experiment



primal



dual

SIGGRAPH2008

## Near-Field Reflectance Fields

SIGGRAPH2008

- Sequential Sampling
  - Dual Photography
  - Symmetric Photography based on  $\mathcal{H}$ -matrices
- 
- first methods for acquiring the global light transport in arbitrary scenes

## Challenges

SIGGRAPH2008

- densely sampled 8D reflectance fields
- upsampling / interpolation
- dynamic near-field reflectance fields
- interactive relighting
- global illumination with reflectance fields
- theory on the complexity of reflectance fields

## Thanks

SIGGRAPH2008

- BMBF (FKC01IMC01)
- DFG - Emmy Noether Program



Max Planck Center  
for visual computing and communication

mpi  
max planck institut  
informatik

<http://mpi-inf.mpg.de/~lensch>

## The Human Face Scanner Project

Tim Weyrich  
Princeton University

ICCV 2007 Tutorial

Rio de Janeiro, Oct 15, 2007

## Facial Appearance Acquisition

“Grand challenge” in appearance acquisition:

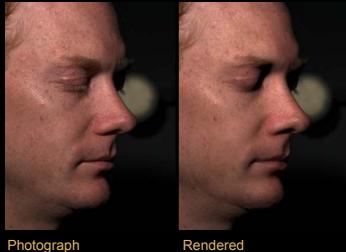
- Complex reflectance and scattering properties
- *In vivo* measurements required
- High expectation by the observer
- Appearance editing desirable



## Analysis of Human Faces

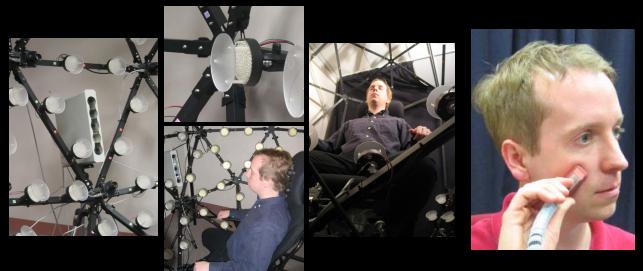
*Analysis of Human Faces  
Using a Measurement-Based  
Skin Reflectance Model*  
[Weyrich et al. 2006]

joint work at  
ETH Zurich, Switzerland,  
and Mitsubishi Electric Research  
Laboratories, Cambridge, MA



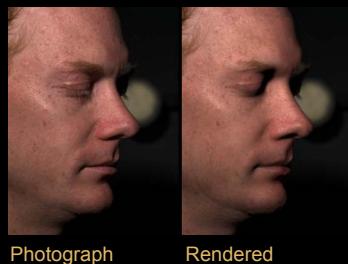
## Objectives

- Capture facial appearance



## Objectives

- Capture facial appearance
- Reconstruct realistic face models



## Objectives

- Capture facial appearance
- Reconstruct realistic face models
- High-level controls to alter appearance



## Capturing Face Appearance



- Explicit Modeling

- Geometry + texture  
[PIGHIN ET AL. 1998]



[PIGHIN ET AL. 1998]

- Image-based Methods

- Reflectance fields  
[DEBEVEC ET AL. 2000],  
[HAWKINS ET AL. 2004]



[HAWKINS ET AL. 2004]

## Skin Reflectance Models



- BRDF (*bi-directional reflectance distribution function*)

- BRDF approximation of scattering  
[HANRAHAN AND KRUEGER 1993], [STAM 2001]

- Image-based BRDF [MARSCHNER ET AL. 1999]

- BSSRDF (*bi-directional surface scattering reflectance distribution function*)

- Single-layered skin model [JENSEN ET AL. 2001]
  - Multi-layered skin model [DONNER AND JENSEN 2005/2006]

- BTF (*bi-directional texture function*)

- Spatially varying reflectance of skin patches  
[CULA AND DANA 2002]

## Appearance Editing



- Image-based editing

- Manual editing by skilled artists
  - Melanin/hemoglobin model  
[TSUMURA ET AL. 2003]



[TSUMURA ET AL. 2003]

- Morphable face model

[BLANZ AND VETTER 1999],  
[FUCHS ET AL. 2005]



[BLANZ AND VETTER 1999]

## Production Environment



- Gemini Man

[WILLIAMS ET AL. 2005]



© ILM [HERY 2003]

- Hulk, Harry Potter II

[HERY 2003/2005]



[BORSHUKOV 2003]

- Matrix

[BORSHUKOV 2003]

- Spider Man II

[SAGAR ET AL. 2004]

## Project Contributions



- Acquisition hardware for the facial BSSRDF
  - Translucency measurements
  - Facial reflectance fields
- Practical skin model to be fitted
  - Simple, but realistic
  - Suited for production environments
- Analysis of physiological parameters
- Intuitive appearance editing framework

## Outline



- Skin appearance acquisition
- Face data processing
- Reflectance Model Fit
- Reflectance Analysis
- Appearance Transfer

## Skin Appearance



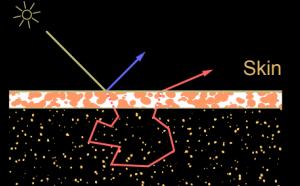
- Skin most important for facial appearance
- Main effects due to skin's translucent layers



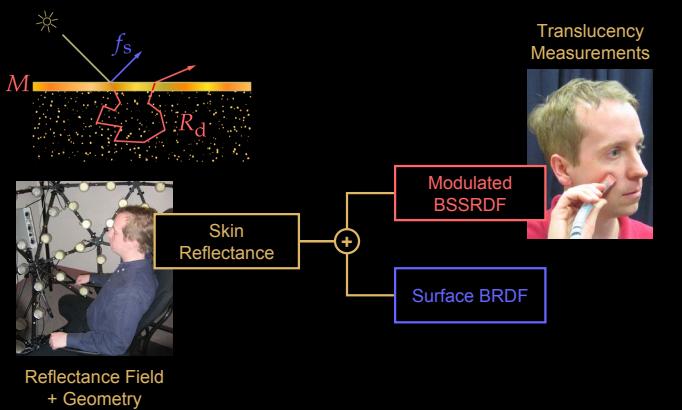
## Skin Appearance



- Skin most important for facial appearance
- Main effects due to skin's translucent layers
- Light transport affected by
  - Air/skin interface (reflectance/refraction)
  - Epidermis, Dermis (scattering/absorption)



## Reflectance Acquisition



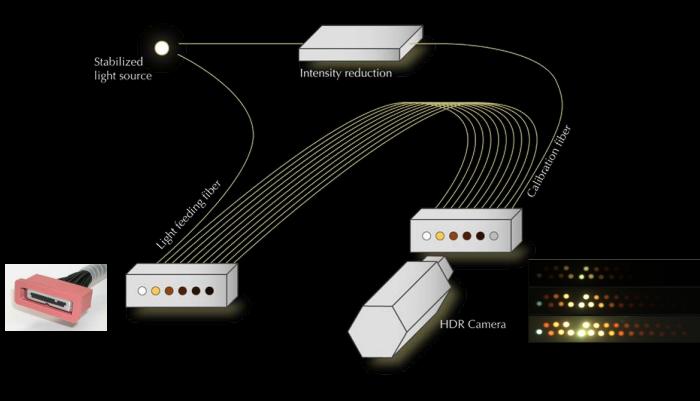
## "BSSRDF Gun"



- Subcutaneous light transport measurements
- Measures translucency (mean free path  $\ell$ )
  - Contact measurements
  - Light transport through optical fibers
- Suction pump ensures contact



## "BSSRDF Gun"



## Reflectance Field Acquisition



- Spherical acquisition dome
  - 16 cameras @ 1300 x 1030
  - 150 LED light sources
  - Commercial 3D scanner



## Reflectance Field Acquisition



- Spherical acquisition dome
  - 16 cameras @ 1300 x 1030
  - 150 LED light sources
  - Commercial 3D scanner
- Dual-exposure HDR



## Reflectance Field Acquisition



- Spherical acquisition dome
  - 16 cameras @ 1300 x 1030
  - 150 LED light sources
  - Commercial 3D scanner
- Dual-exposure HDR
- 25 seconds



## Sample Reflectance Field

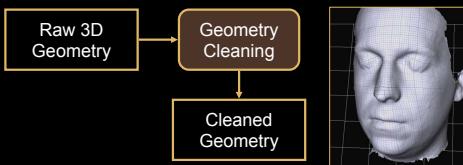


## Outline

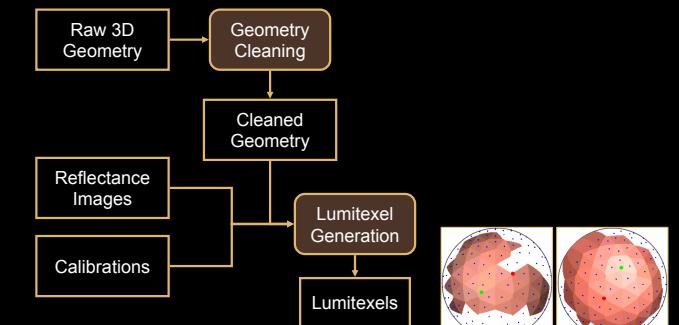


- Skin appearance acquisition
- Face data processing
- Reflectance Model Fit
- Reflectance Analysis
- Appearance Transfer

## Overview

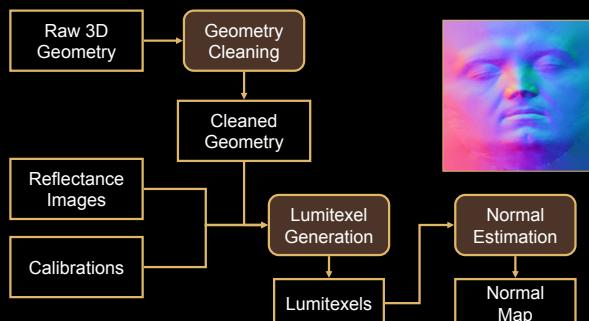


## Overview



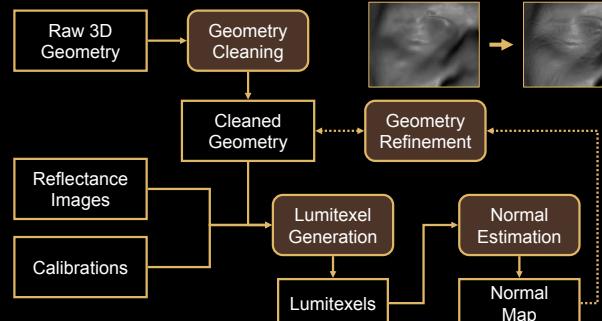
## Overview

SIGGRAPH2008



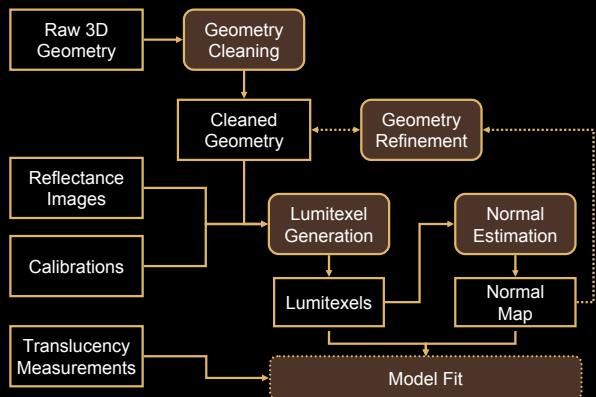
## Overview

SIGGRAPH2008



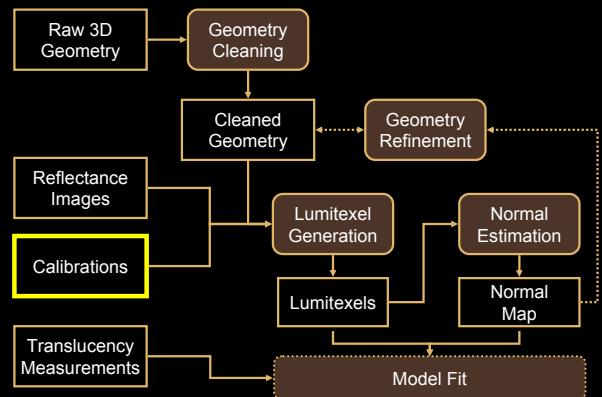
## Overview

SIGGRAPH2008



## Overview

SIGGRAPH2008



## Camera Calibration

SIGGRAPH2008

- Intrinsic
  - Using Intel OpenCV library
  - Based on checker-board images
- Extrinsic
  - $n$ -camera calibration ( $n = 16$ )
  - Euclidian bundle optimization
  - Correspondences from LED swept through volume



## Camera Calibration

SIGGRAPH2008

- Vignetting & color calibration
  - Radial image intensity fall-off
  - Relative sensor calibration of all cameras
  - Affine color correction model [FUNT 2000]
  - Equalizes images taken under identical conditions
- Radiometric calibration
  - Implicitly through light source calibration

## Light Source Calibration



- Desired parameters
  - Light source color
  - Light cone fall-off
- Fluorilon™ reflectance target
  - Perfect diffuse reflector
  - Reflects 99.9% of incident radiance
- Reflectance fields of different orientations
- Fitting 2<sup>nd</sup>-order polynomial to spot cross-section



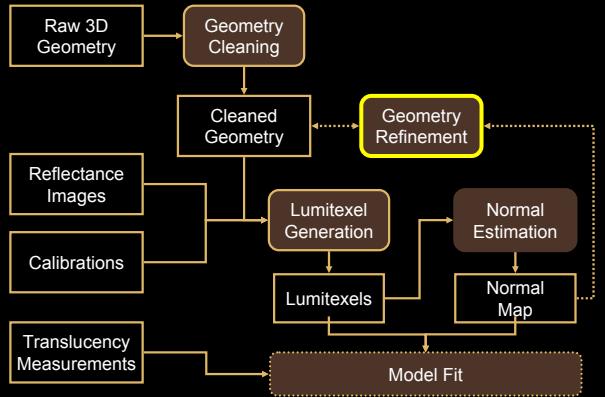
## "BSSRDF Gun" Calibration



- Relative fiber transmittance
  - Light table with opal glass diffuser
- Black image calibration
- Irradiance calibration
  - Skim milk as secondary standard
  - Values as measured by [JENSEN ET AL. 2001]



## Overview

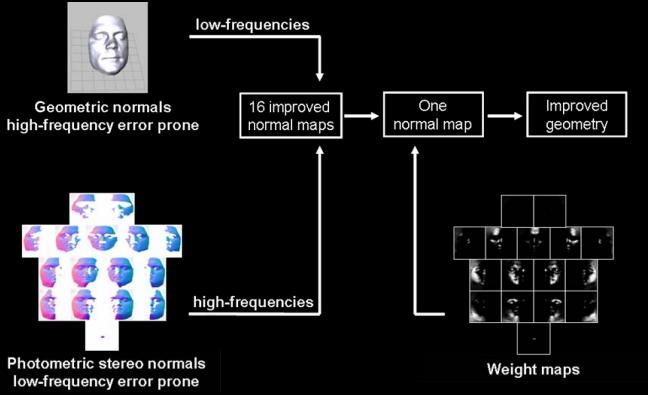


## Geometry Refinement



- Geometry and normal information crucial
- Normal estimation
  - Photometric stereo
  - Lambertian assumption
  - Problem: bias, discontinuities
- Normal and geometry improvement adapting [NEHAB ET AL. 2005]

## Geometry Refinement



## Geometry Refinement

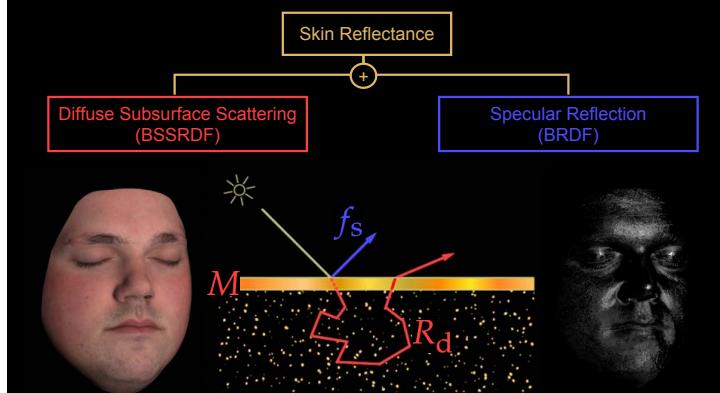


## Outline

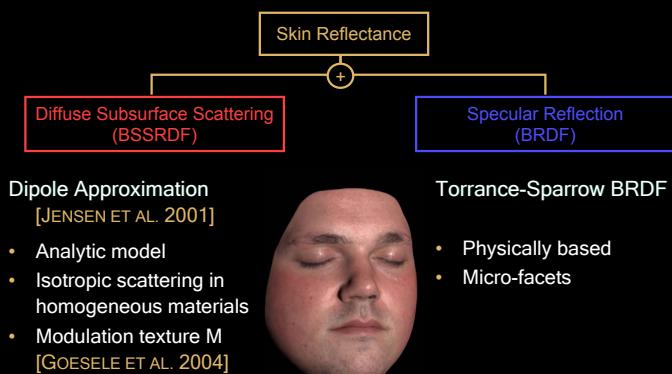
- Skin appearance acquisition
- Face data processing
- Reflectance Model Fit
- Reflectance Analysis
- Appearance Transfer



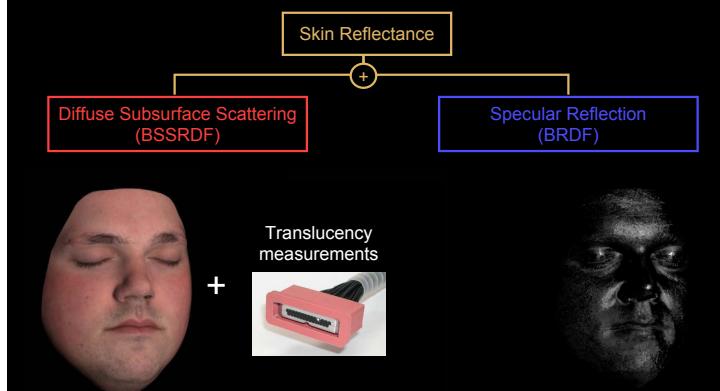
## Skin Reflectance Model



## Skin Reflectance Model



## Model Fit



## Face Reconstruction



Photograph



Reconstruction

## Reconstruction



Photograph



Reconstruction

## Reconstruction

SIGGRAPH2008



Photograph



Reconstruction

## Face Reconstruction

SIGGRAPH2008



## Face Reconstruction

SIGGRAPH2008



## Outline

SIGGRAPH2008

- Skin appearance acquisition
- Face data processing
- Reflectance Model Fit
- Reflectance Analysis
- Appearance Transfer

## The Face Database

SIGGRAPH2008

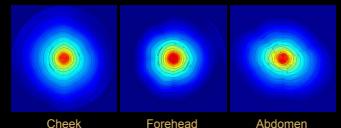
- Scanned 149 subjects A row of six small photographs of various people's faces.
- Classification by
  - Skin type, gender, age, ...
  - Facial regionA 3D rendering of a human face with numbered regions (1-10) and arrows indicating axes for Age, Tan Level, and Skin type.
- Analysis of variation in model parameters

## Translucency Variance

SIGGRAPH2008

- Model validation

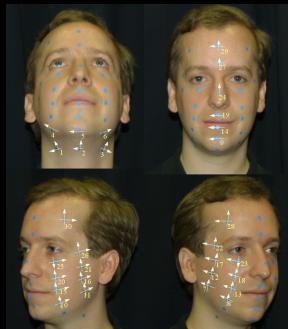
– Facial scattering is isotropic



## Translucency Variance

SIGGRAPH2008

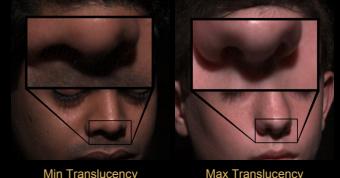
- Model validation
  - Facial scattering is isotropic
- Spatial translucency variance minute



## Translucency Variance

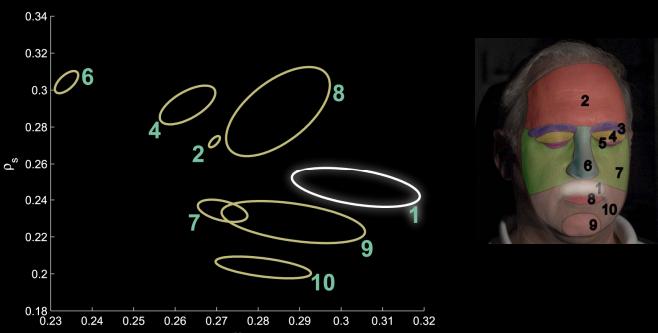
SIGGRAPH2008

- Model validation
  - Facial scattering is isotropic
- Spatial translucency variance minute
- Inter-subject variance negligible
  - Small variance between males and females



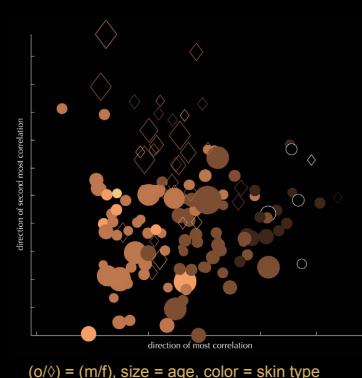
## Spatial BRDF Variance

SIGGRAPH2008



## Skin Trait Variations

SIGGRAPH2008



## Outline

SIGGRAPH2008

- Skin appearance acquisition
- Face data processing
- Reflectance Model Fit
- Reflectance Analysis
- Appearance Transfer

## Appearance Editing

SIGGRAPH2008

- From parameter observations derive intuitive user controls
  - Main tool: texture synthesis [HEEGER AND BERGEN 1995], [MATUSIK ET AL. 2005]
  - Applicable to all model parameter types
    - Add freckles, moles, gloss variations, ...
- General appearance editing framework

## Results Appearance Transfer

SIGGRAPH2008



Target face



Freckles applied

## Results Appearance Transfer

SIGGRAPH2008



Target face



Changed skin type

## Contributions

SIGGRAPH2008

- Acquisition hardware for the facial BSSRDF
  - Translucency measurements
  - Facial reflectance fields
- Practical skin model to be fitted
  - Simple, but realistic
  - Suited for production environments
- Analysis of physiological parameters
- Intuitive data-driven appearance editing framework
- Published appearance database of human faces

## Results Appearance Transfer

SIGGRAPH2008



Target face



Lotion applied, Stubbles reduced

## Potential Extensions

SIGGRAPH2008

- Facial hair
  - Eye-brows, eye-lashes
  - Beard, stubbles
  - Velvety hair
- Spectral measurements
- Multi-layered model using additional model assumptions (e.g. [DONNER AND JENSEN 2006])
- *Will increasing measurement accuracy increase the perceived degree of realism?*



## Q & A

Appearance database online at:  
<http://www.merl.com/facescanning/>